

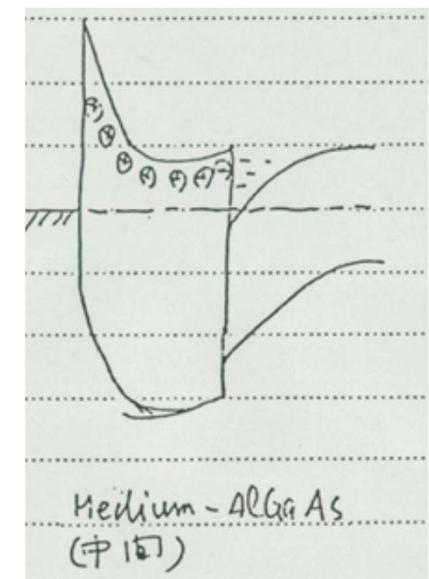
# The High-Electron Mobility Transistor at 30: Impressive Accomplishments and Exciting Prospects

J. A. del Alamo

Microsystems Technology Laboratories  
MIT

International Conference on  
Compound Semiconductor Manufacturing Technology

May 16-19, 2011



# Outline

- Introduction
- HEMT electronics
- Modulation-doped structures in physics
- Future prospects

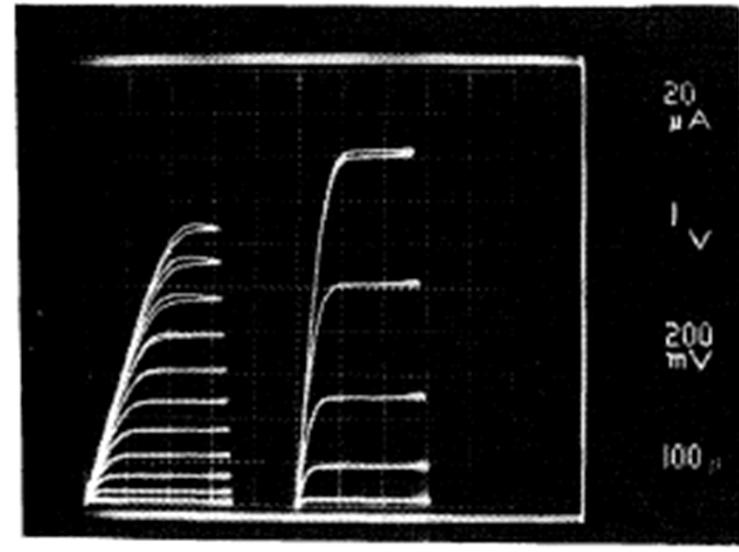
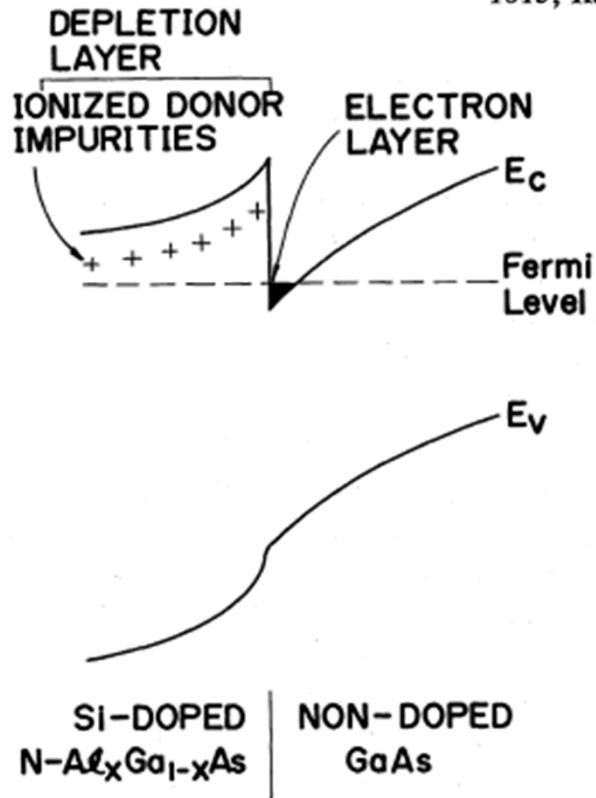
# The High Electron Mobility Transistor

## A New Field-Effect Transistor with Selectively Doped GaAs/n-Al<sub>x</sub>Ga<sub>1-x</sub>As Heterojunctions

Takashi MIMURA, Satoshi HIYAMIZU, Toshio FUJII  
and Kazuo NANBU

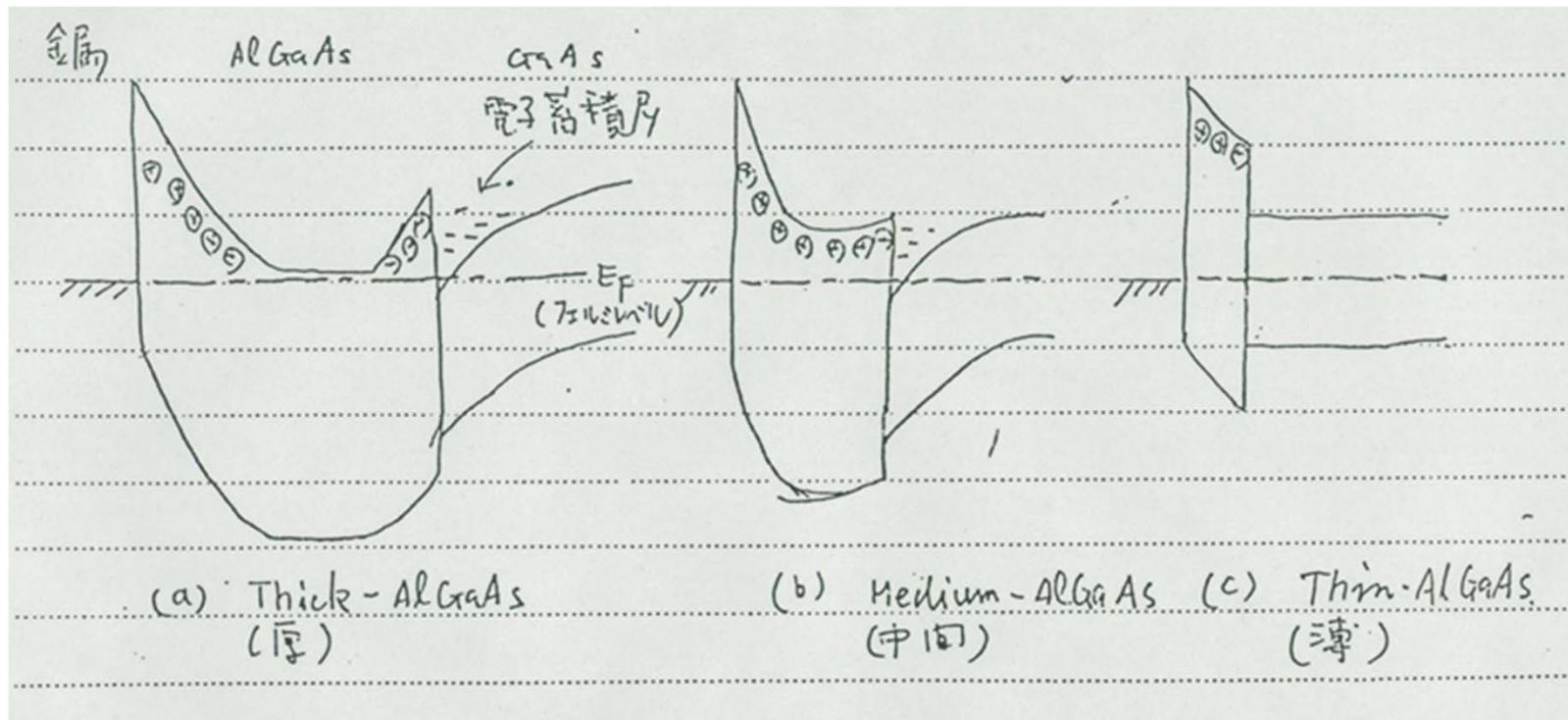
Fujitsu Laboratories Ltd.,  
1015, Kamikodanaka, Nakahara-ku, Kawasaki 211

(Received March 24, 1980)



Mimura, JJAPL 1980

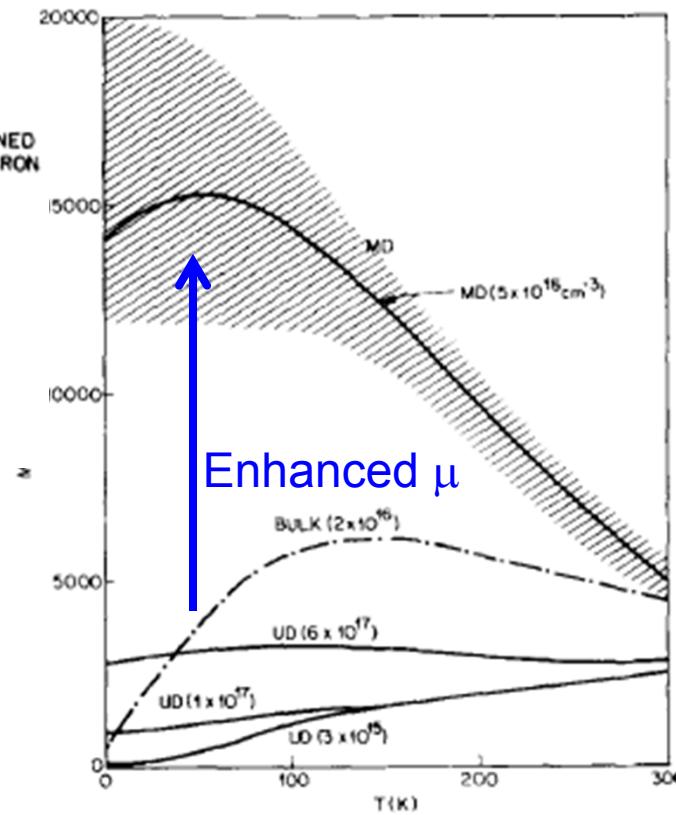
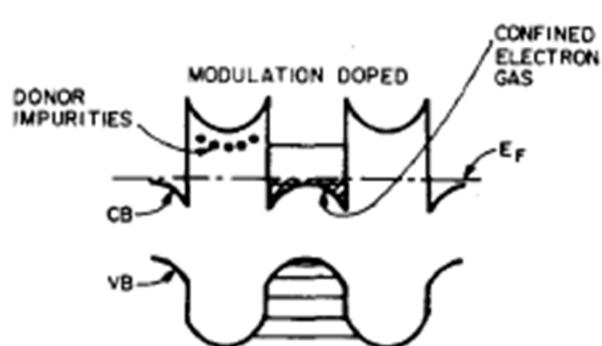
# Energy band diagrams in Mimura's patent application (Aug. 16, 1979)



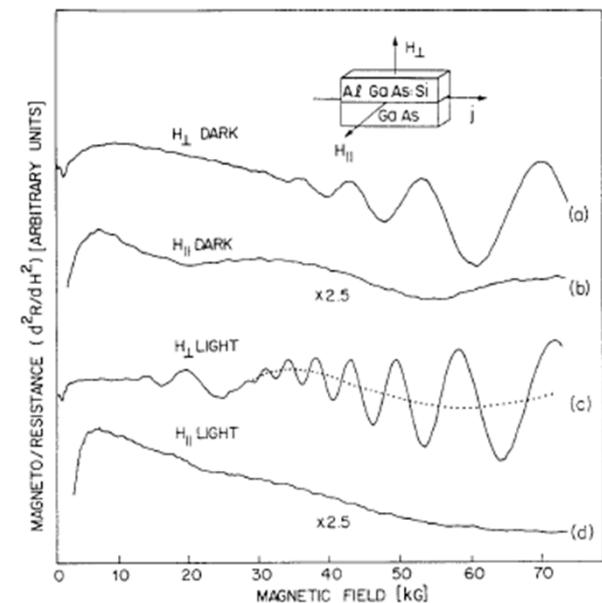
Courtesy of Takashi Mimura (Fujitsu)

# Modulation doping

- High electron mobility in modulation-doped AlGaAs/GaAs heterostructures
- 2 DEG at AlGaAs/GaAs interface

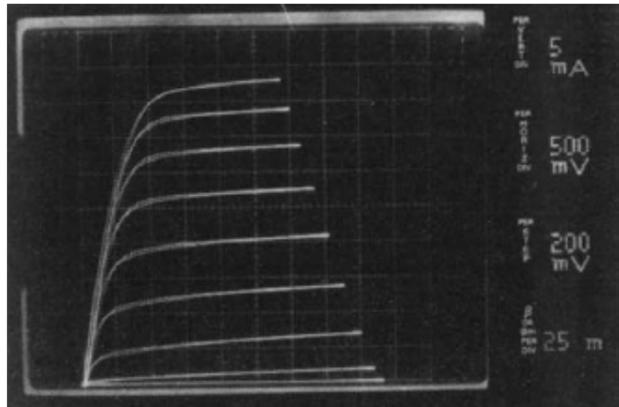


Dingle, APL 1978

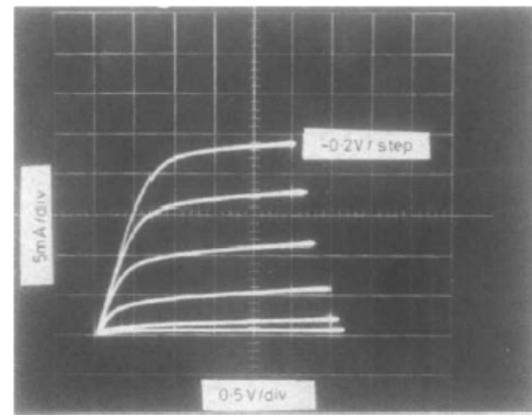


Störmer, Solid St  
Comm 1979

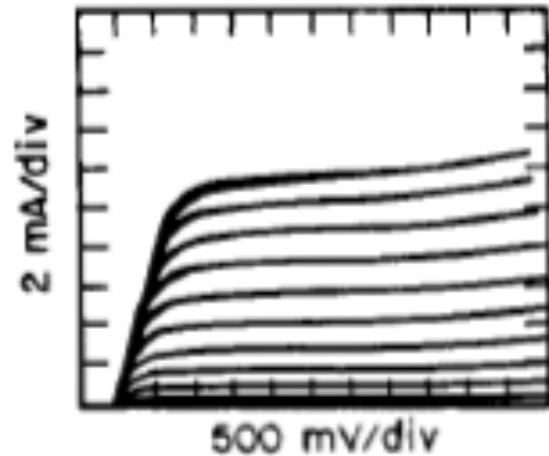
# HEMT by other name...



Thomson-CSF:  
Two-Dimensional Electron  
Gas FET (TEGFET)  
Laviron, EL 1981

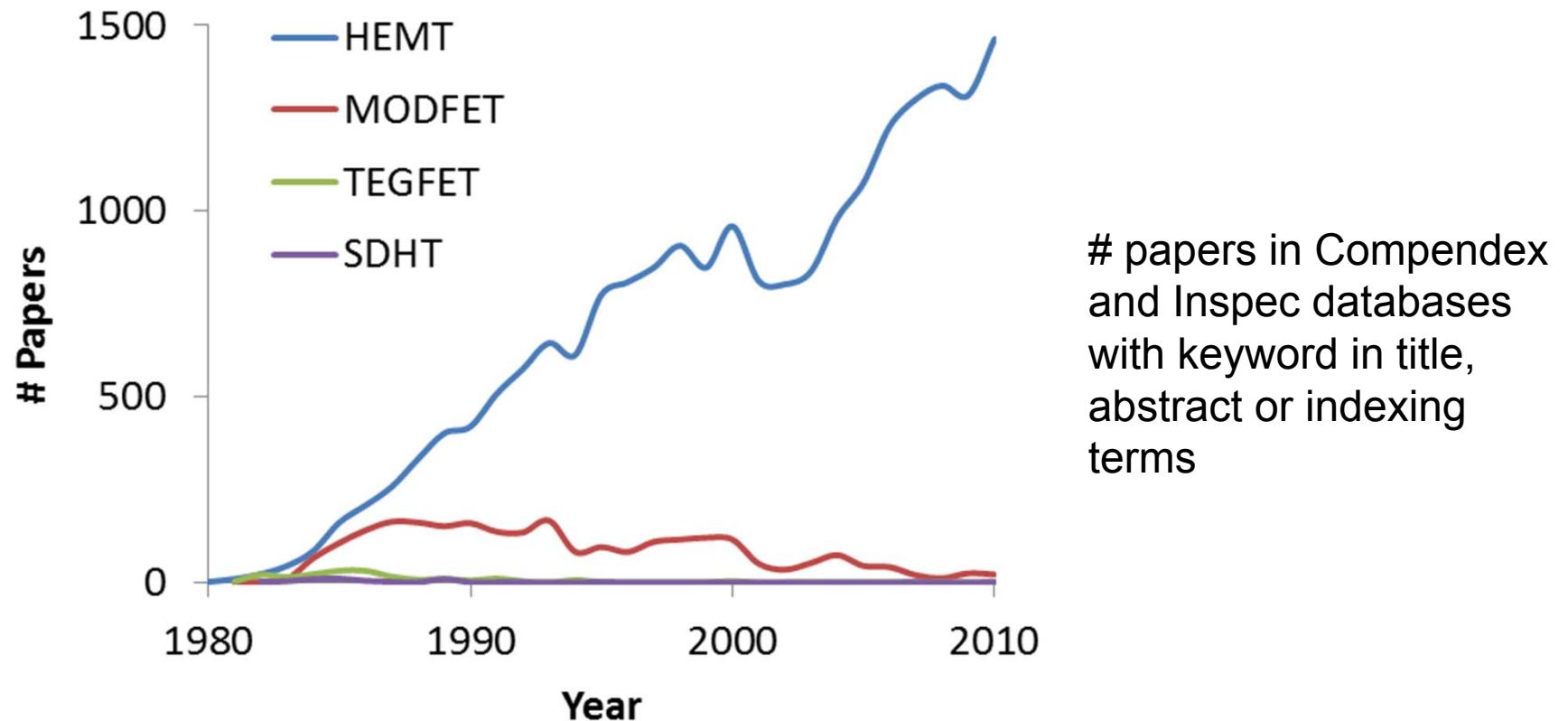


U. Illinois:  
Modulation-Doped FET  
(MODFET)  
Su, EL 1982



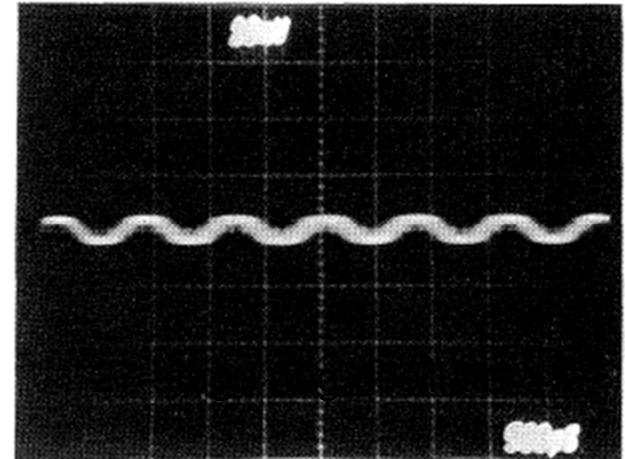
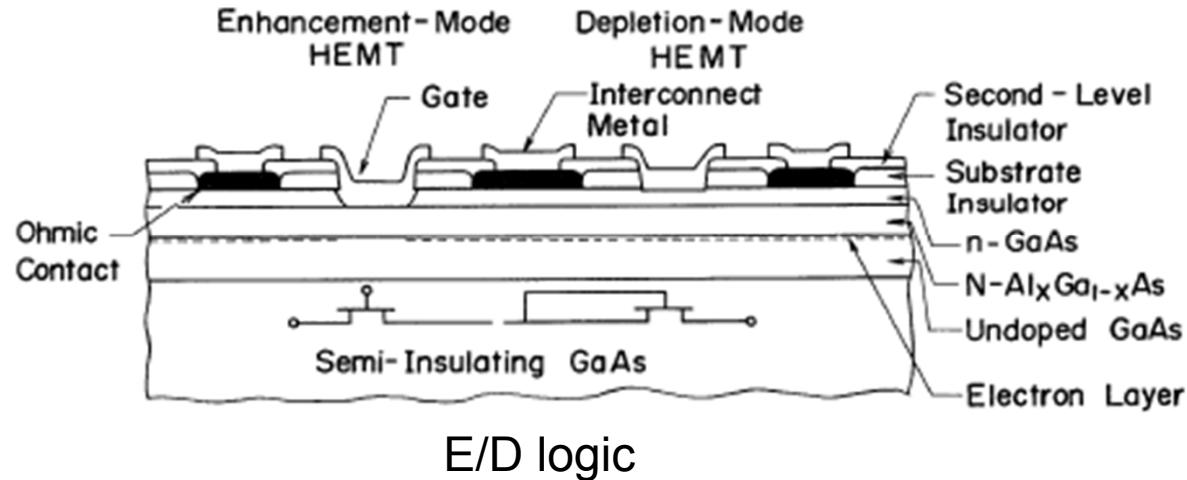
Bell Labs.:  
Selectively-Doped  
Heterojunction Transistor  
(SDHT)  
DiLorenzo, IEDM 1982

# And the winner is...

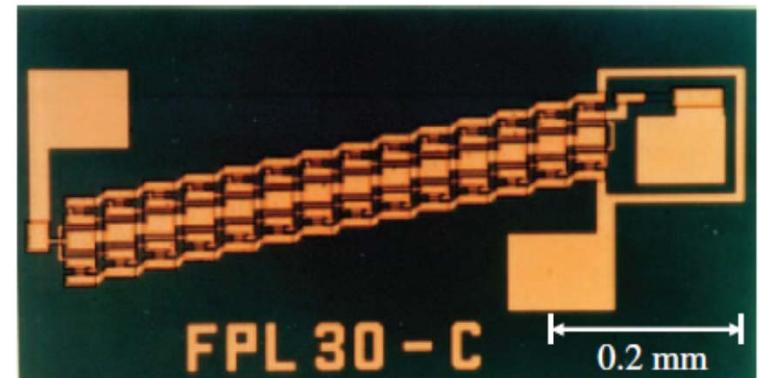


Data courtesy of Angie Locknar (MIT Libraries)

# First HEMT IC



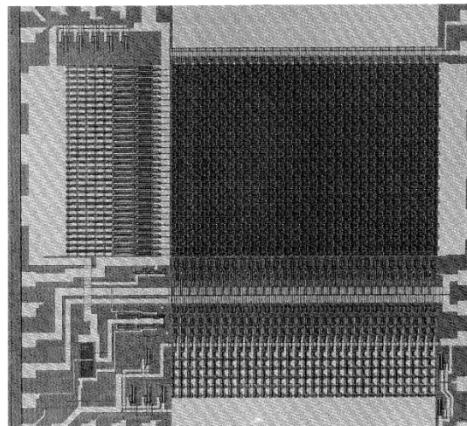
“The switching delay of 17.1 ps is the lowest of all the semiconductor logic technologies reported thus far.”



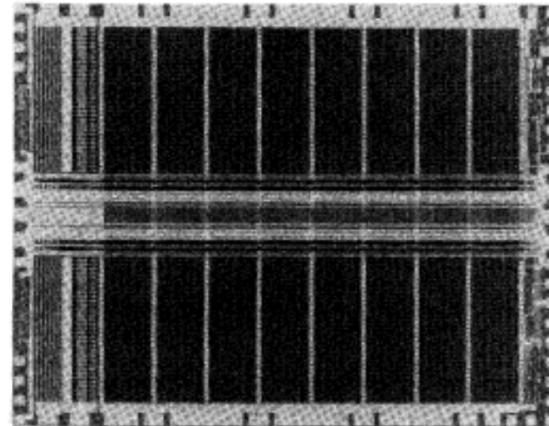
Mimura, JJAPL 1981

“HEMT technology is presenting new possibilities for high-speed low-power very-large-scale-integration.”

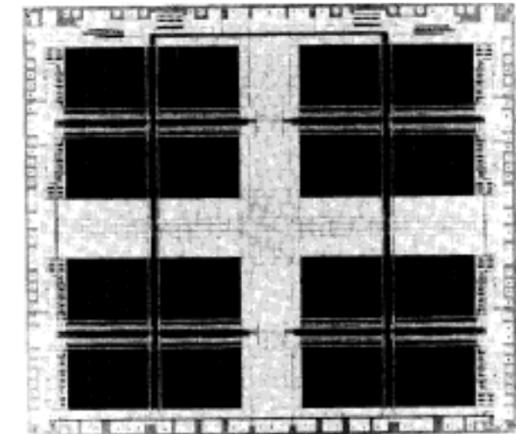
# HEMT ICs ride Moore's Law



1 Kb SRAM



16 Kb SRAM



64 Kb SRAM

1984: 1 Kb SRAM (7,244 HEMTs, 8.7 mm<sup>2</sup>)

1984: 4 Kb SRAM (26,864 HEMTs, 21 mm<sup>2</sup>)

1987: 16 Kb SRAM (107,519 HEMTs, 24 mm<sup>2</sup>)

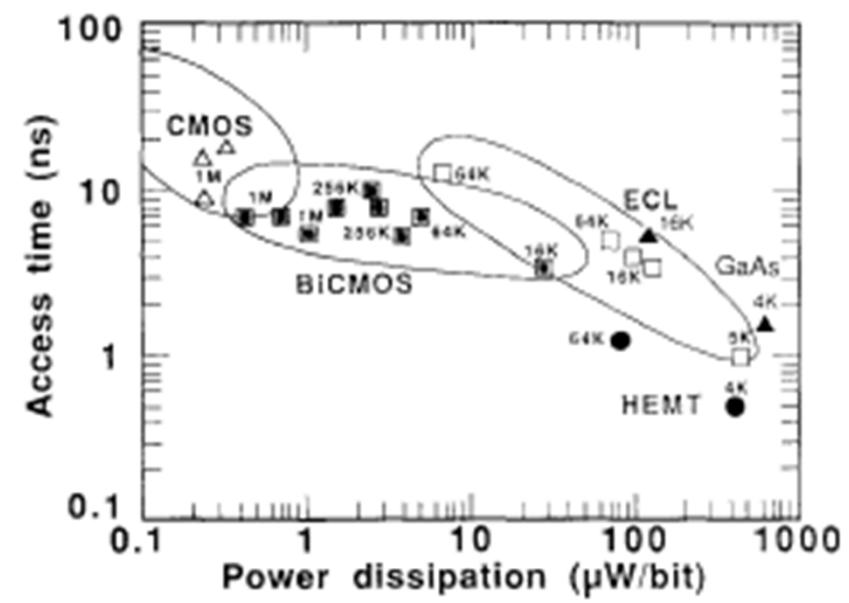
1991: 64 Kb SRAM (>462,000 HEMTs, 48 mm<sup>2</sup>)

Watanabe, TED 1987

Suzuki, JSSC 1991

Abe, JSSC 1991

Abe, JVST 1987



# First HEMT LNA

20 GHz 4-stage HEMT LNA (1983)

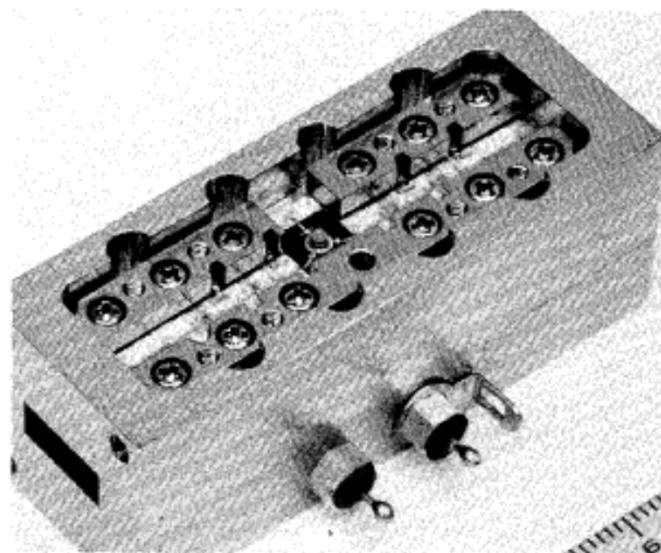
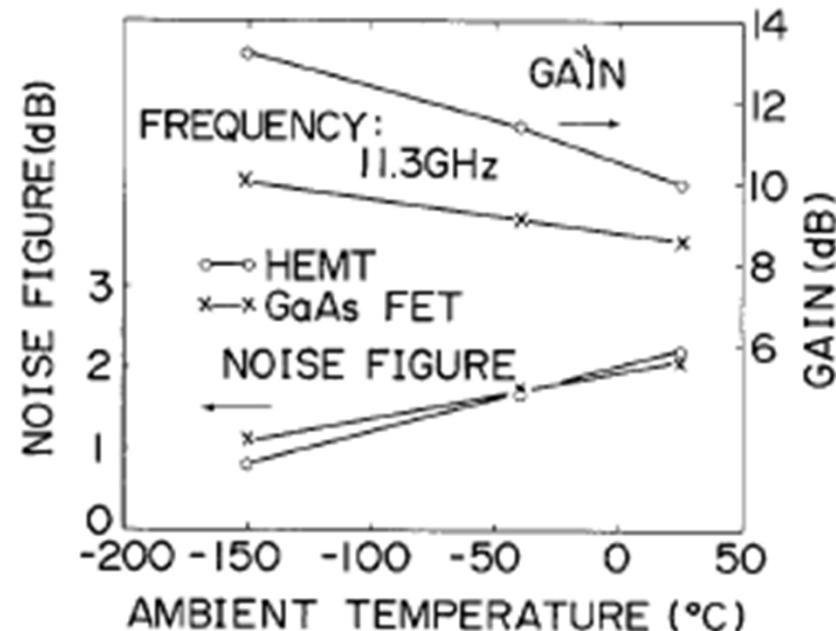


FIGURE 4—A 20GHz 4-stage HEMT amplifier.

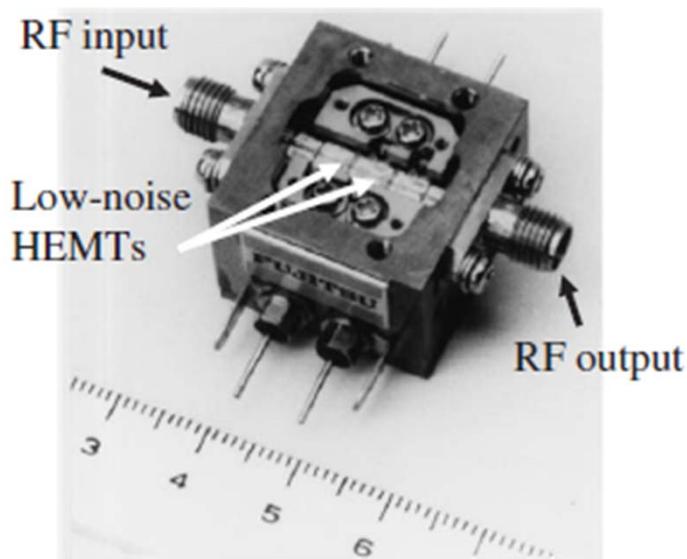


Niori, ISSCC 1983

Great improvement in noise characteristics as  $T \downarrow$

# Early commercial applications

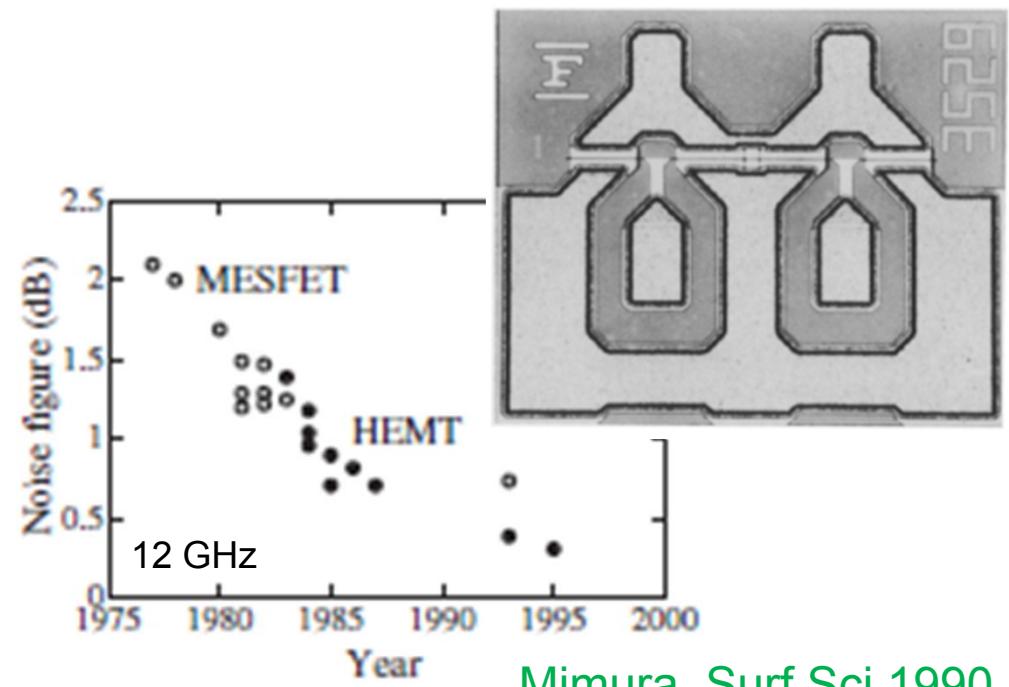
First commercial HEMT product:  
cryogenic low-noise amplifier at  
Nobeyama Radio Observatory  
(1985)



Mimura, JJAP 2005

Used to discover new interstellar  
molecule C<sub>6</sub>H in Taurus  
Molecular Cloud (1986)

First mass market product: 0.25 μm  
GaAs HEMTs for LNA in DBS  
receiver (1987)

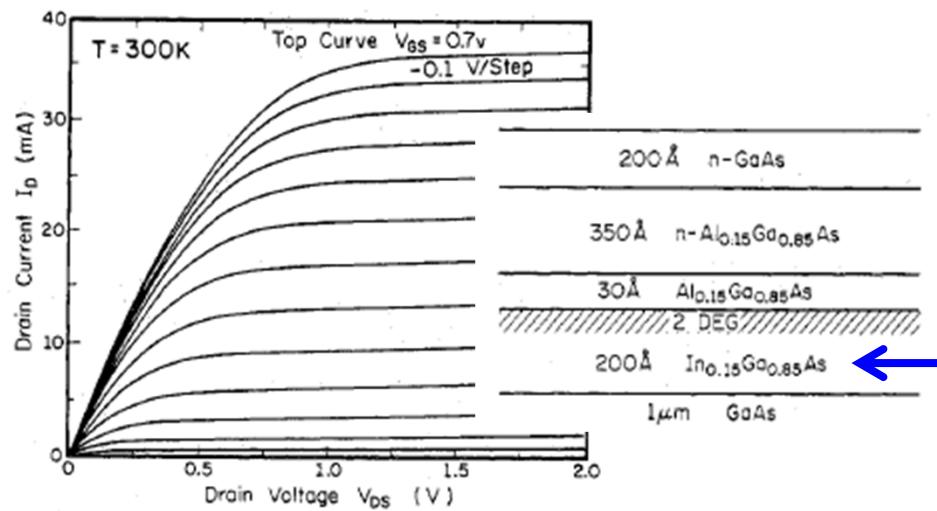


Mimura, Surf Sci 1990

By 1988, world wide production of  
HEMT receivers reached 20  
million/year

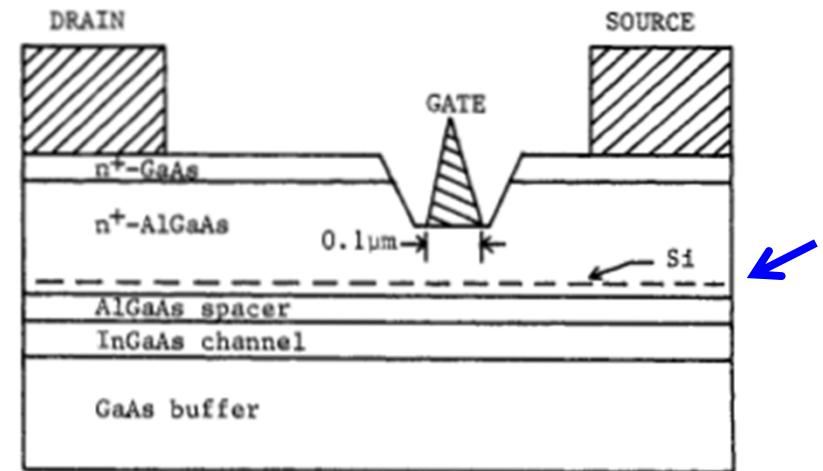
# Delta-doped pseudomorphic HEMT

Pseudomorphic HEMT



Ketterson, EDL 1985

Delta doping



Chao, IEDM 1987

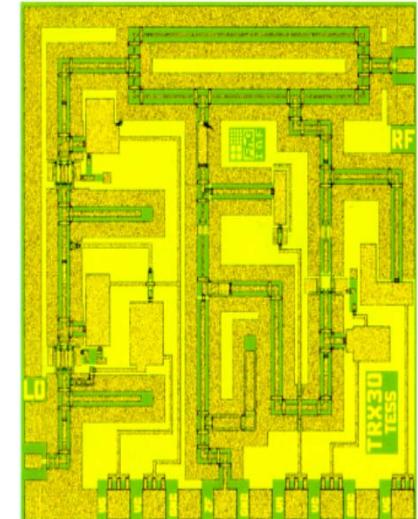
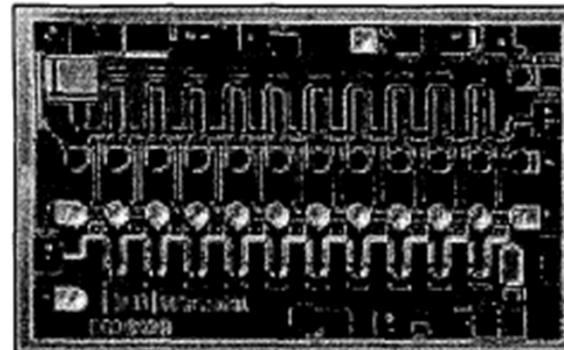
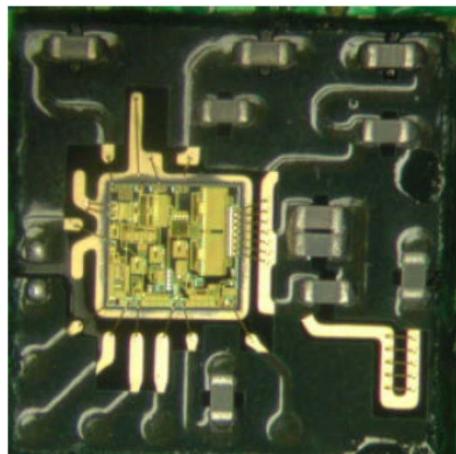
- Motivation: lower  $x$  in Al<sub>x</sub>Ga<sub>1-x</sub>As to avoid carrier freeze-out
- Enhanced transport in InGaAs
- Large  $\Delta E_c \rightarrow$  enhanced current
- Enabled barrier thickness scaling → improved transconductance and scalability
- Enhancement of breakdown voltage



# PHEMT ICs

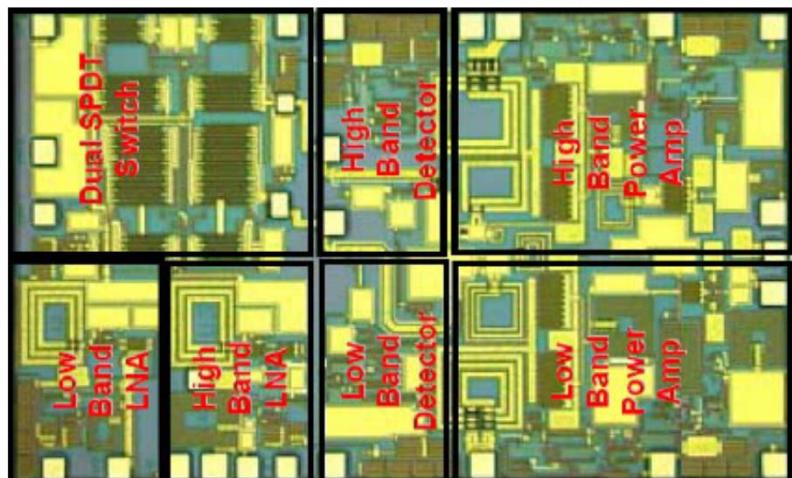
Saturday, February 26, 2011  
TriQuint and Skyworks Power iPhone 5

UMTS-LTE PA module  
Chow, MTT-S 2008



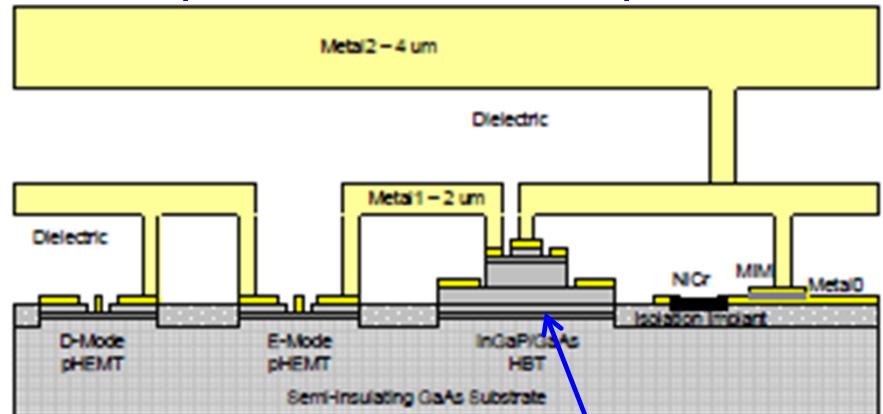
77 GHz transceiver  
Tessmann, GaAs IC  
1999

40 Gb/s modulator driver  
Carroll, MTT-S 2002



Single-chip WLAN MMIC, Morkner, RFIC 2007

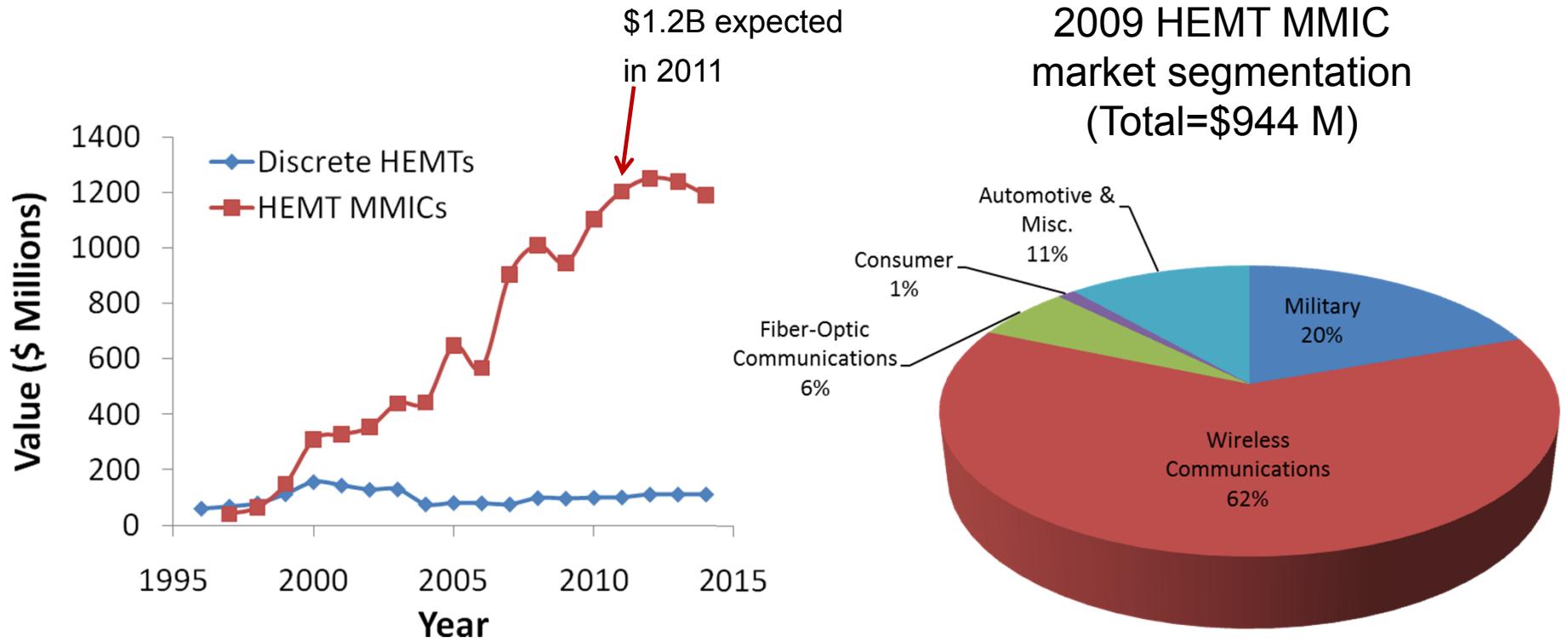
## Bipolar/E-D PHEMT process



Henderson, Mantech 2007

Single MOCVD growth 13

# HEMT markets

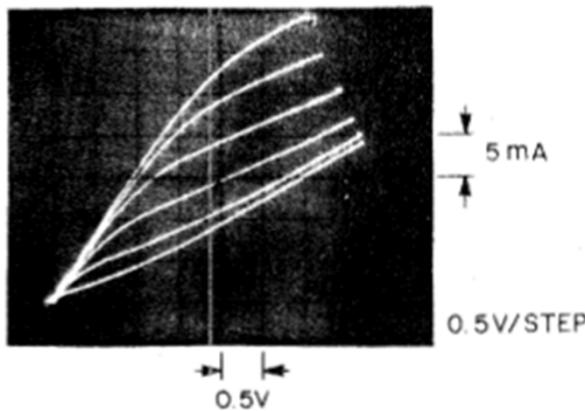
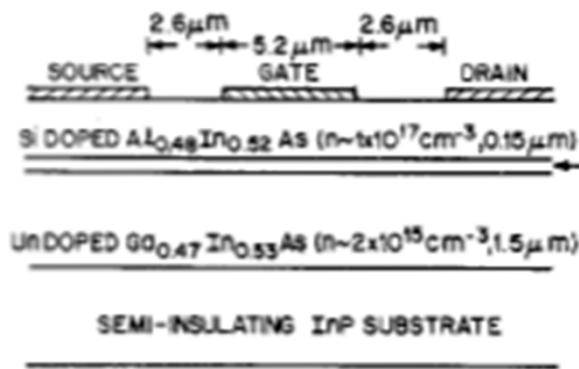


- Biggest market: wireless communications
- Biggest applications: cell phone handsets, WLAN, base stations and CATV

Data courtesy of Eric Higham (Strategy Analytics)

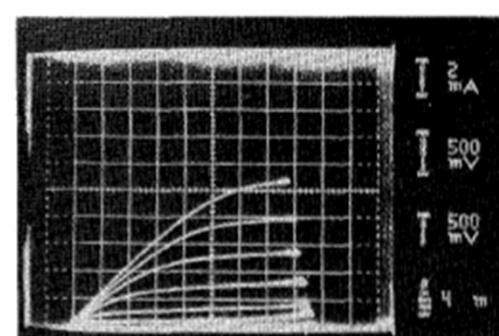
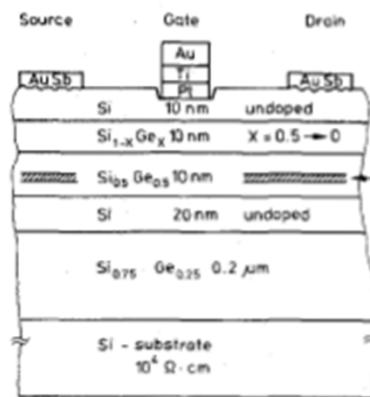
# HEMTs in other material systems

InAlAs/InGaAs on InP



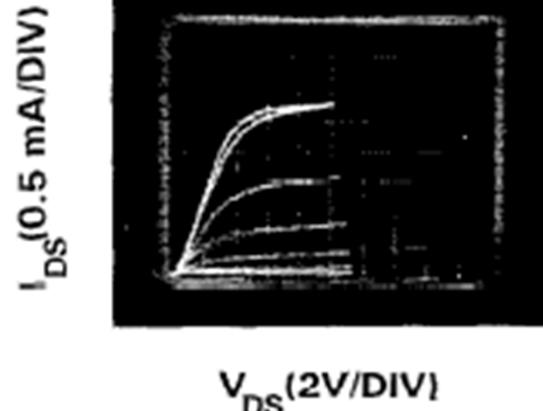
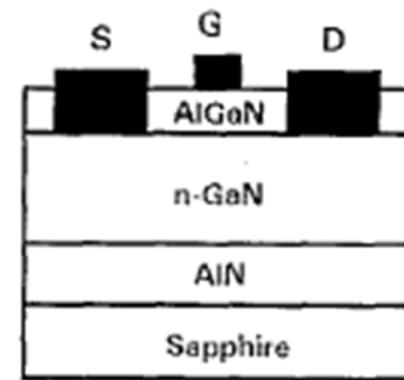
Chen, EDL 1982

SiGe/Si



Daembkes, TED 1986

AlGaN/GaN

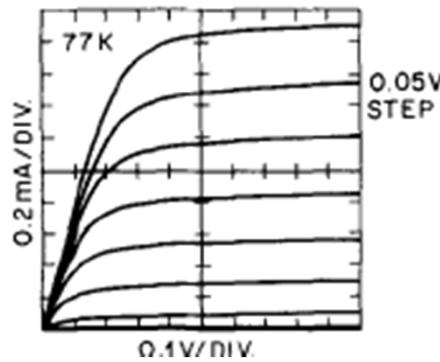
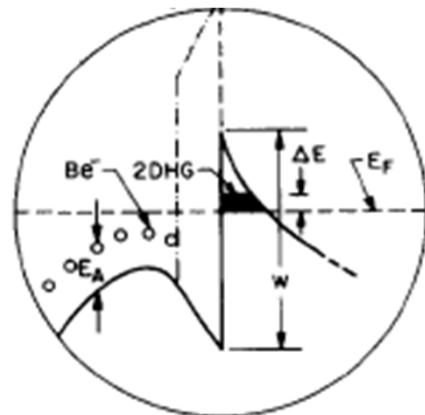


Khan, APL 1993

Also: AlSb/InAs, AlInSb/InSb, etc

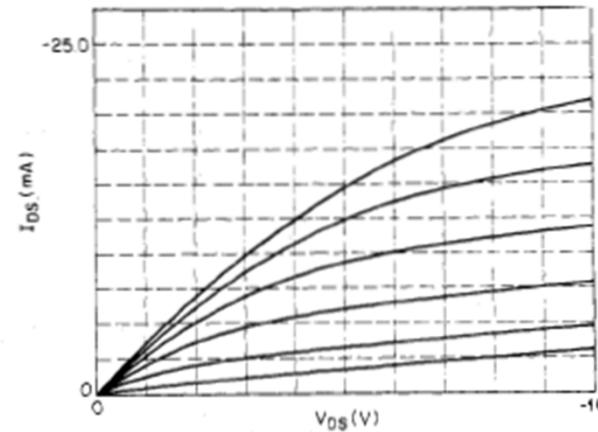
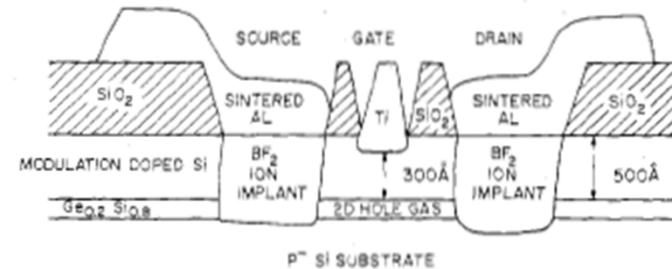
# High Hole Mobility Transistors

AlGaAs/GaAs



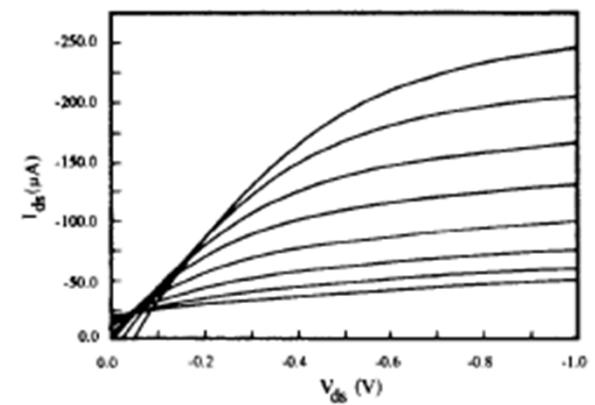
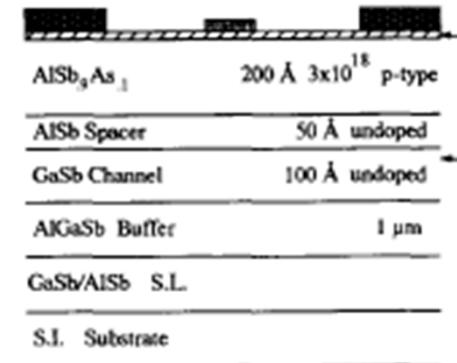
Störmer, APL 1984

Si/SiGe



Pearsall, EDL 1986

AlSbAs/GaSb

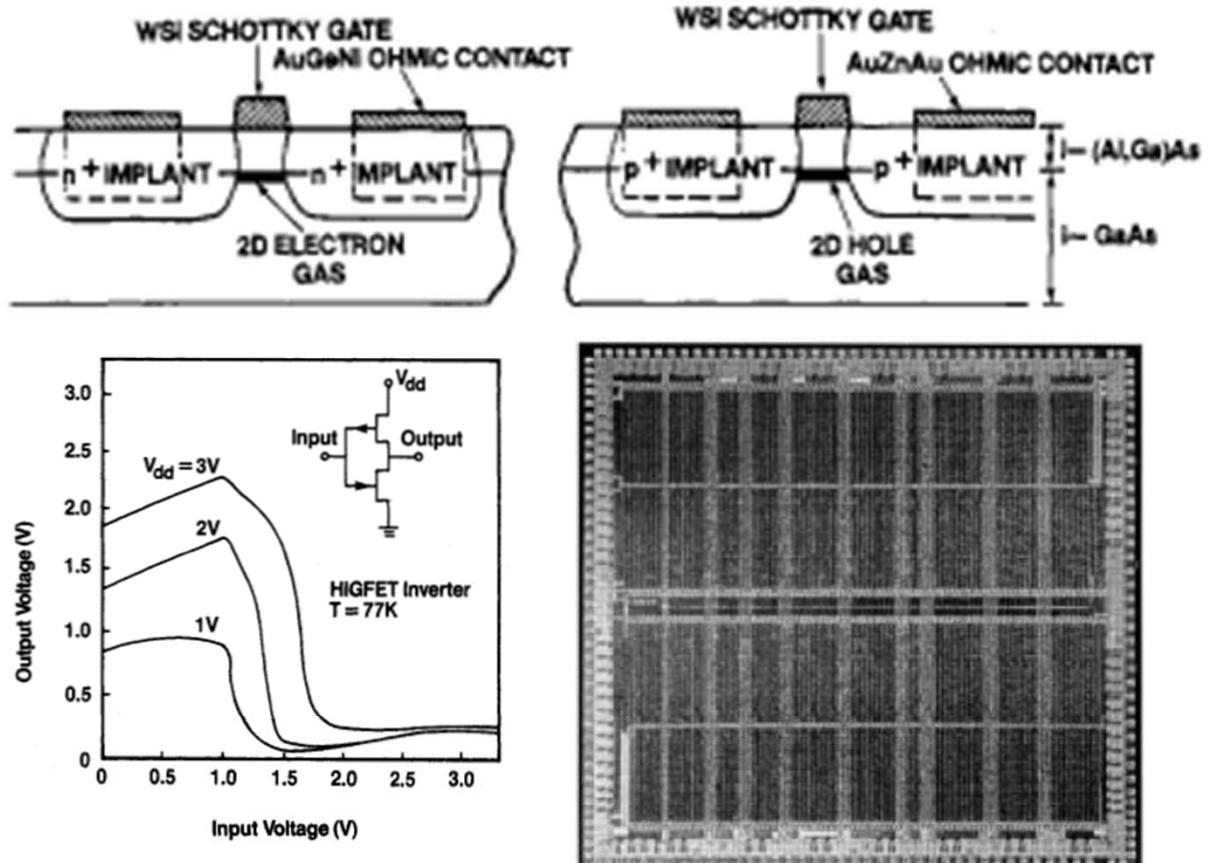
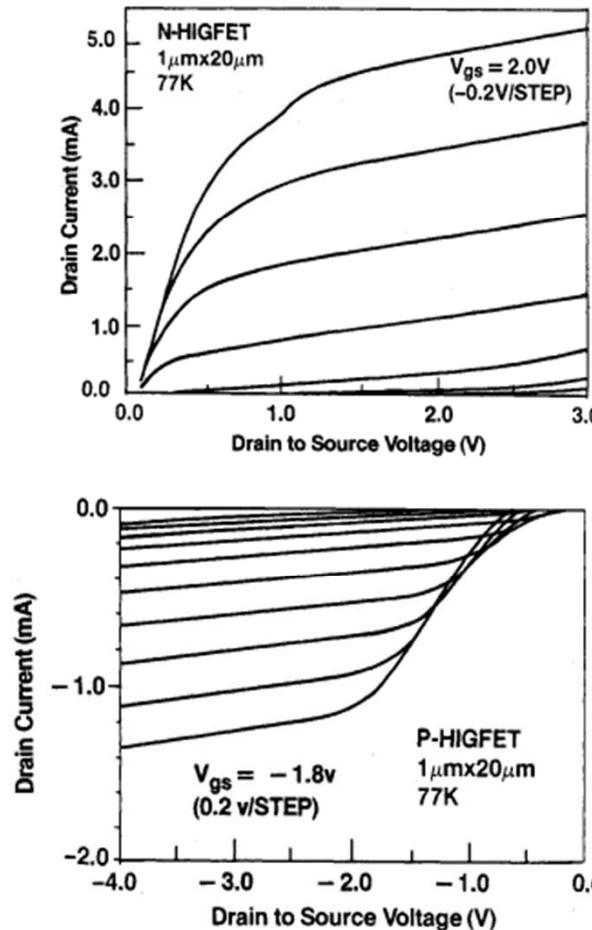


Luo, EDL 1990

Also: AlGaAs/InGaAs, InAlAs/InGaAs, AlGaSb/InGaSb, InGaN/GaN, etc

# Complementary HEMT/HHMT ICs

AlGaAs/GaAs system



Cirillo, IEDM 1985

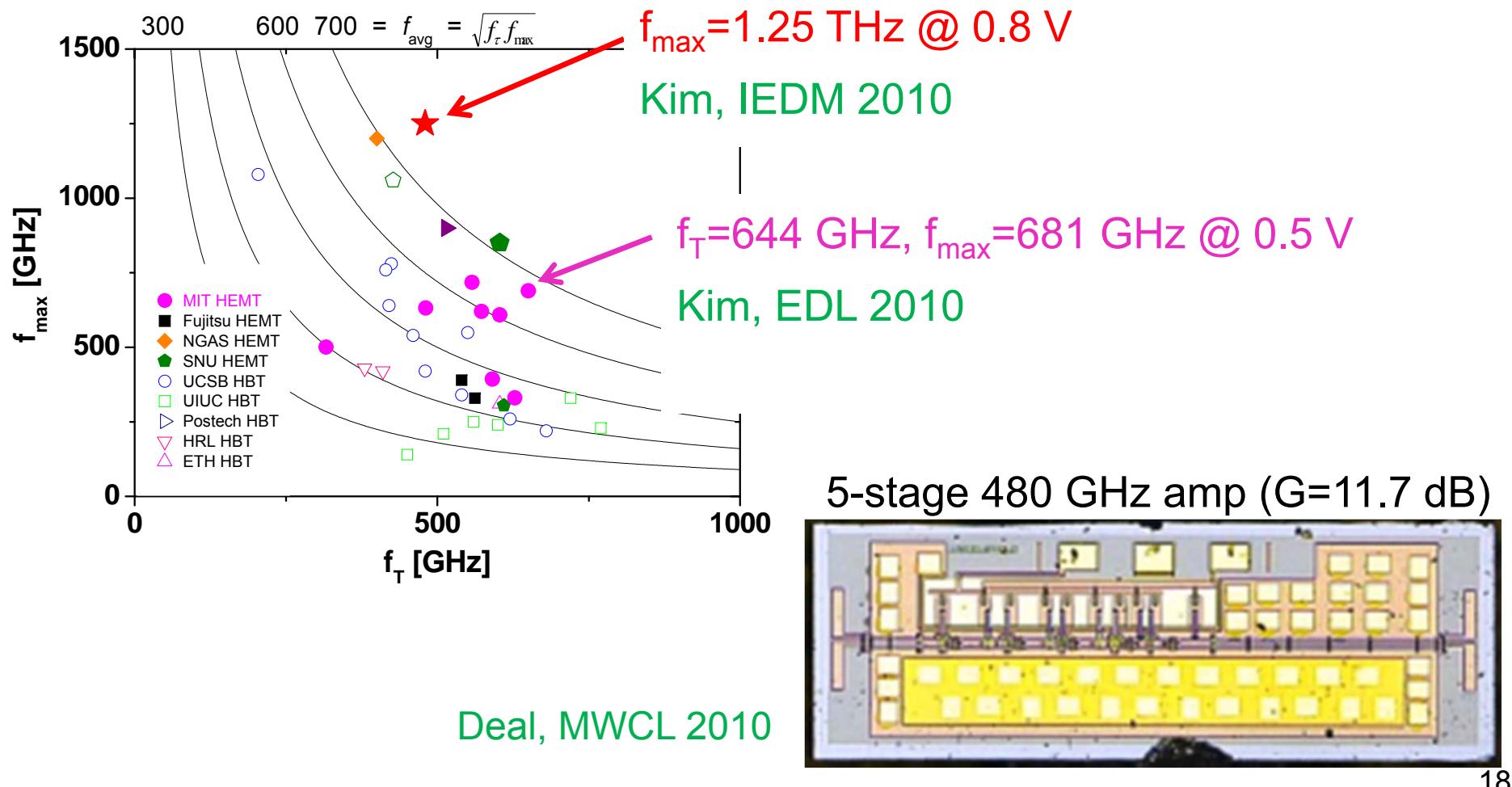
171,000 transistor 16-channel signal distribution system

Also: InAlAs/InGaAs system

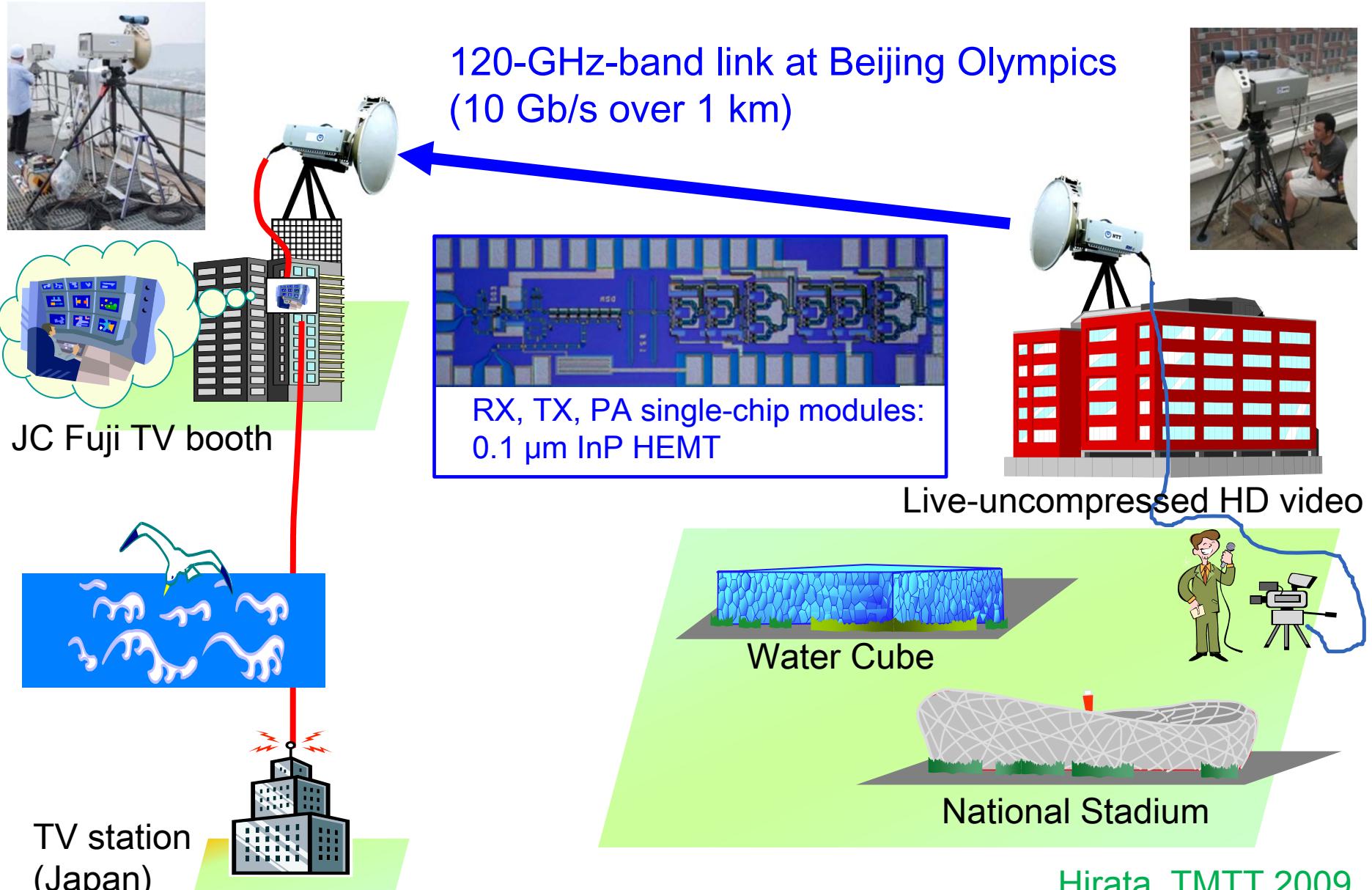
Brown, Trans VLSI Syst 1998

# InAlAs/InGaAs HEMTs on InP

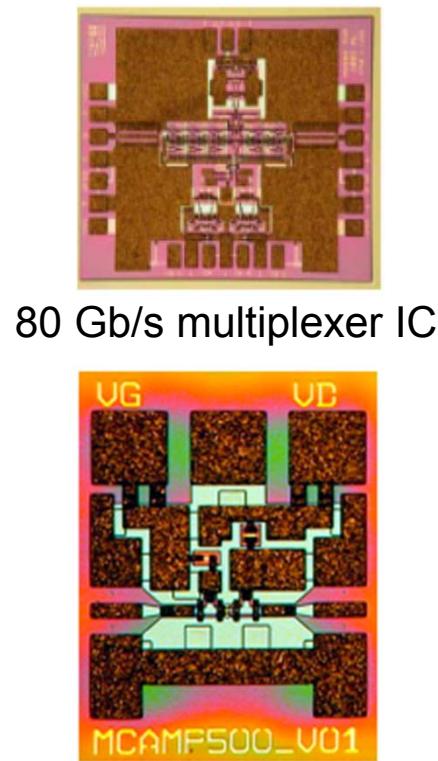
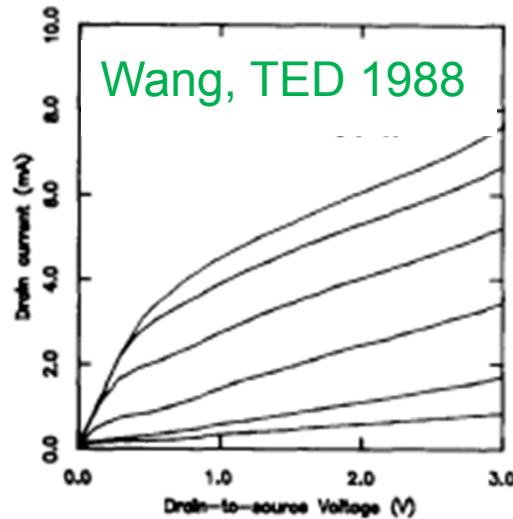
Uniqueness: very high mobility and velocity  
→ record frequency response at very low voltage



# InAlAs/InGaAs HEMT mmw ICs



# InAlAs/InGaAs Metamorphic HEMTs *on GaAs*



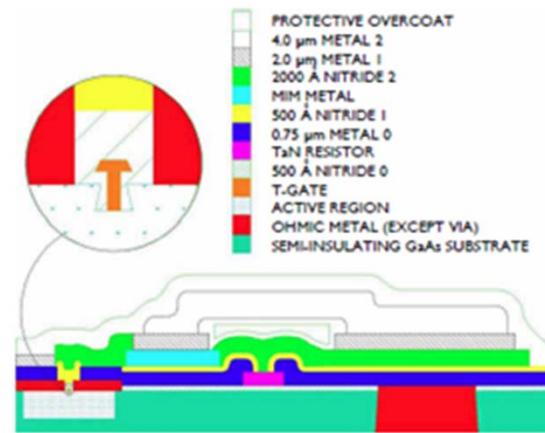
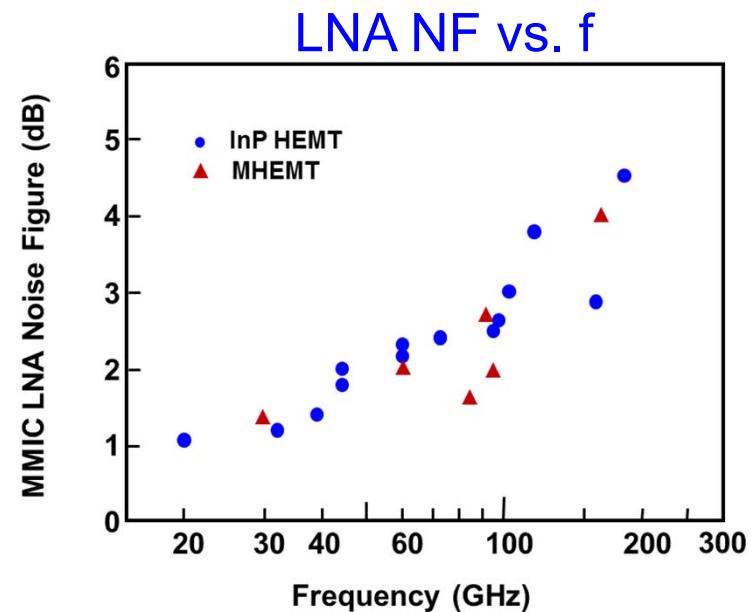
Wurfl, GAAS 2004

Tessmann, CSIC 2010

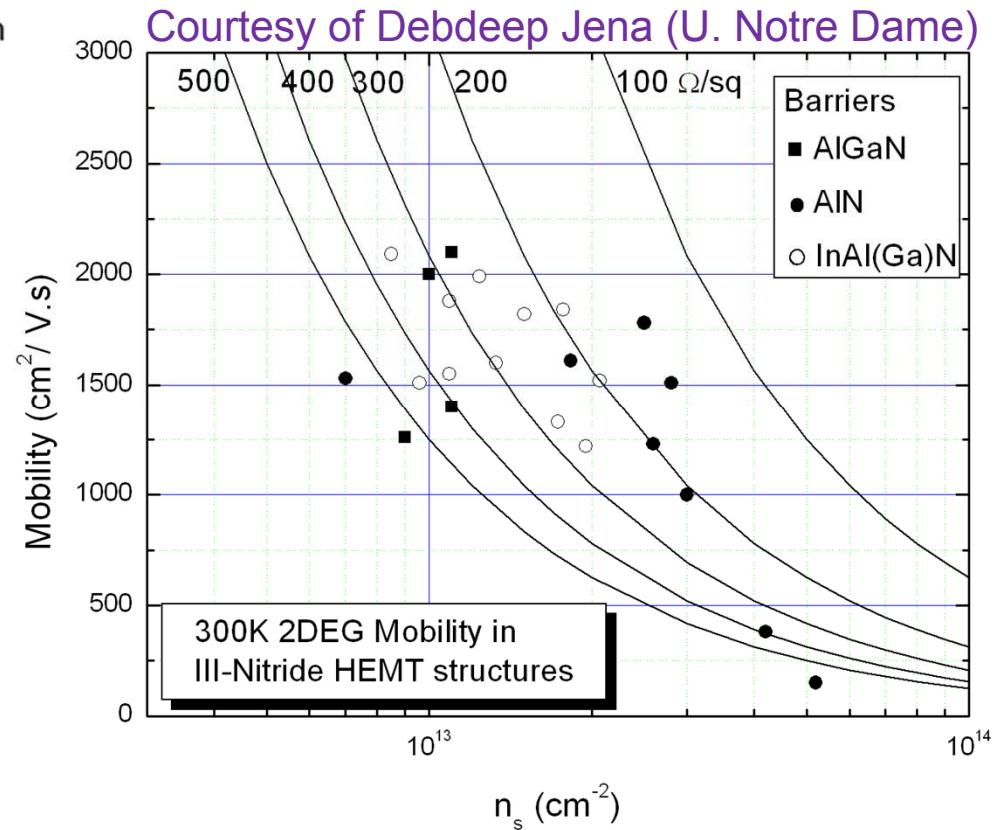
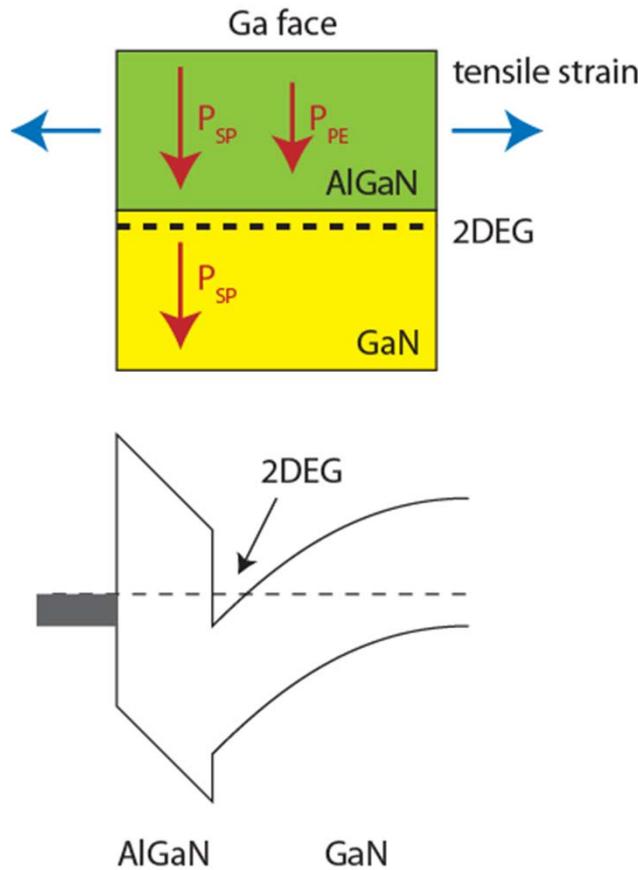
Single-stage 500 GHz  
LNA (G=3.3 dB)

- Comparable performance to InP substrate
- Improved manufacturability
- Lower cost
- Well established packaging technology

LNA data courtesy of Phillip Smith (BAE Systems)



# Polarization doping in Nitrides

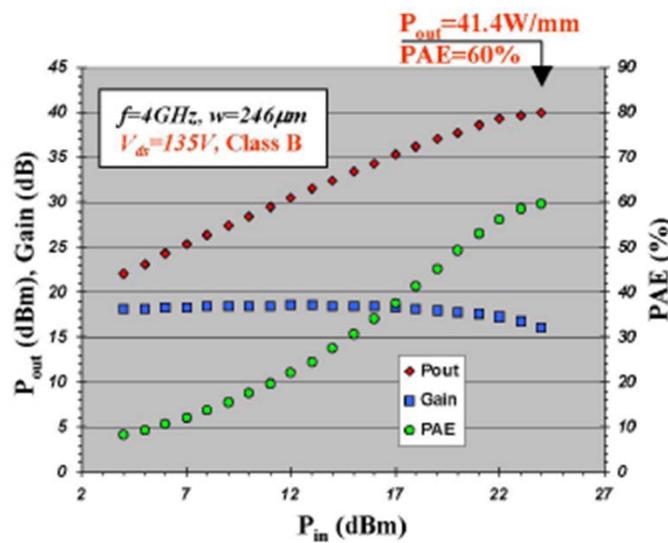
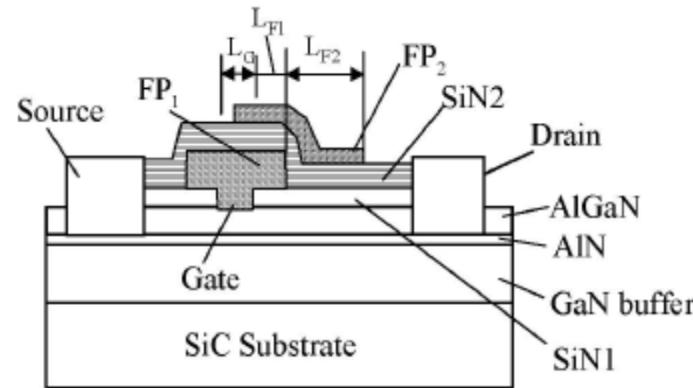


AlGaN/GaN system uniqueness:

- Strong polarization “doping” → high current operation
- High breakdown voltage → high voltage operation
- High saturation velocity → high frequency operation

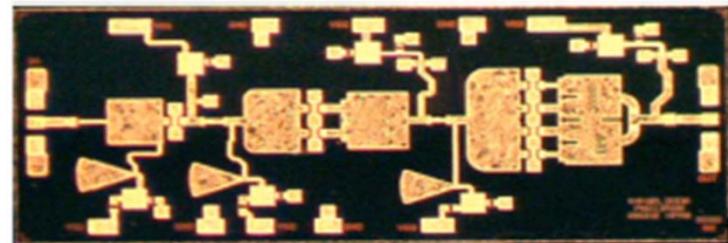
Breakthrough high-f PAs

# Breakthrough RF Power in GaN HEMTs



$P_{out} > 40 \text{ W/mm}$ ,  
over 10X GaAs!

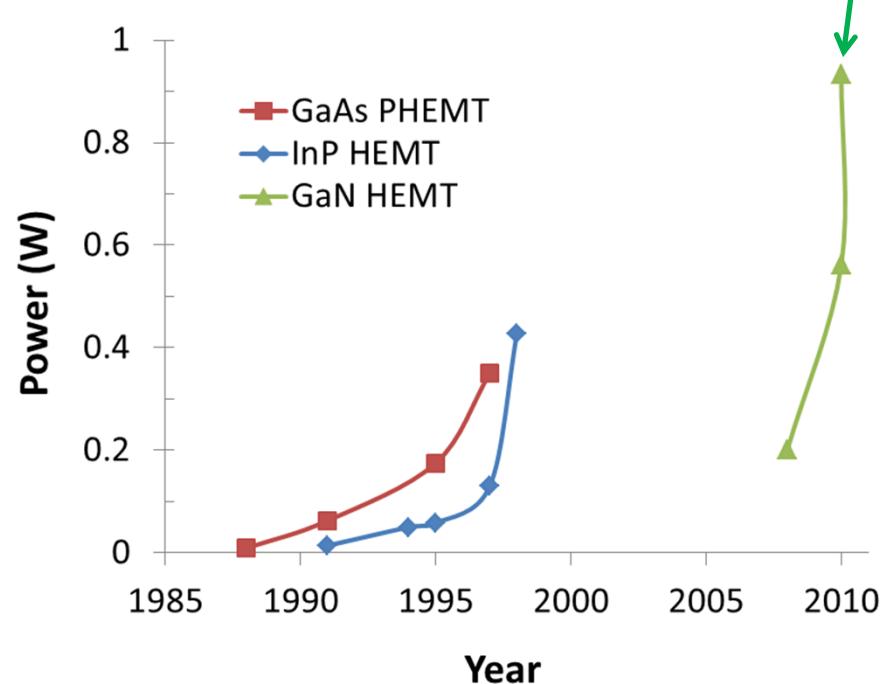
Wu, DRC 2006



Micovic, MTT-S 2010

Micovic, Cornell  
Conf 2010

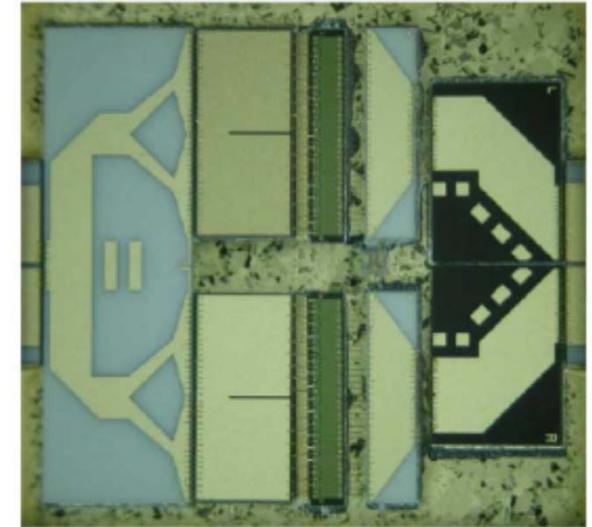
94-95 GHz MMIC PAs:



# GaN HEMT in the field



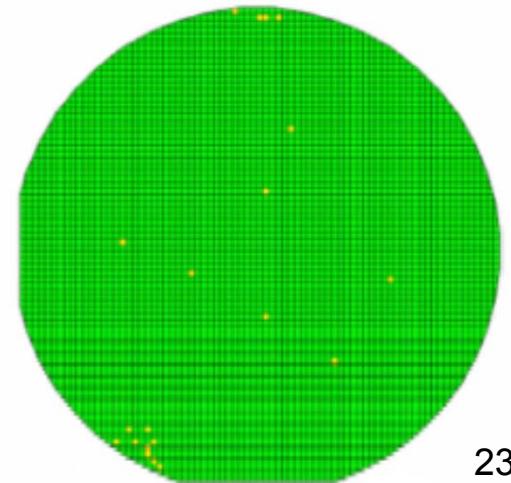
Counter-IED Systems  
(CREW)



200 W GaN HEMT for  
cellular base station  
**Kawano, APMC 2005**



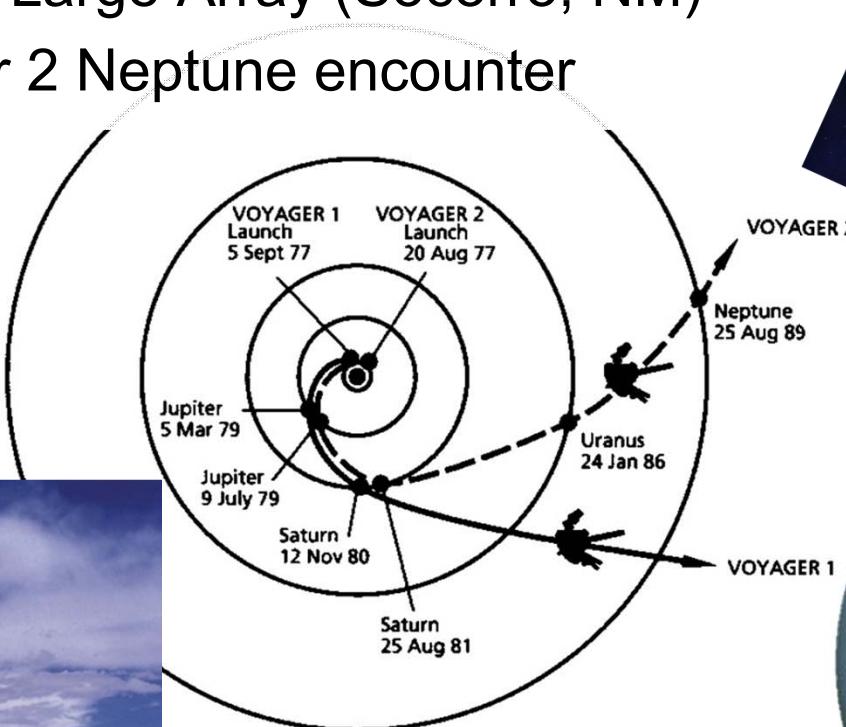
100 mm GaN-on-SiC volume  
manufacturing  
**Palmour, MTT-S 2010**



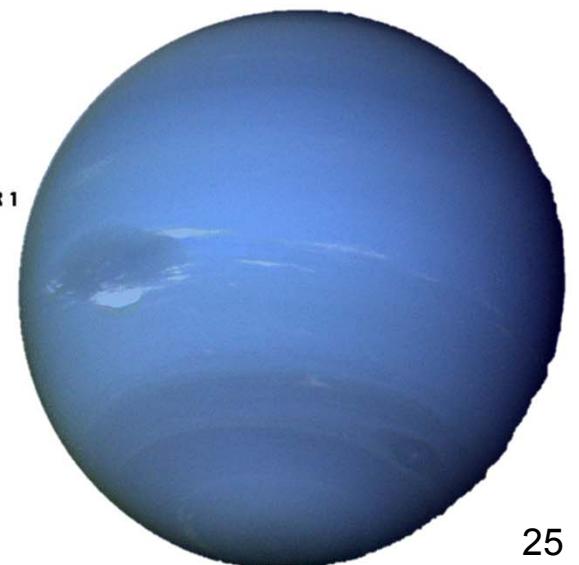
# **Modulation-doped structures in physics**

# Cryogenic HEMTs in radioastronomy

- 1977: launch of Voyager 1 & 2, in mission to four planets
- 1987: AlGaAs/GaAs HEMT amplifiers delivered by GE to Very Large Array (Socorro, NM)
- 1989: Voyager 2 Neptune encounter

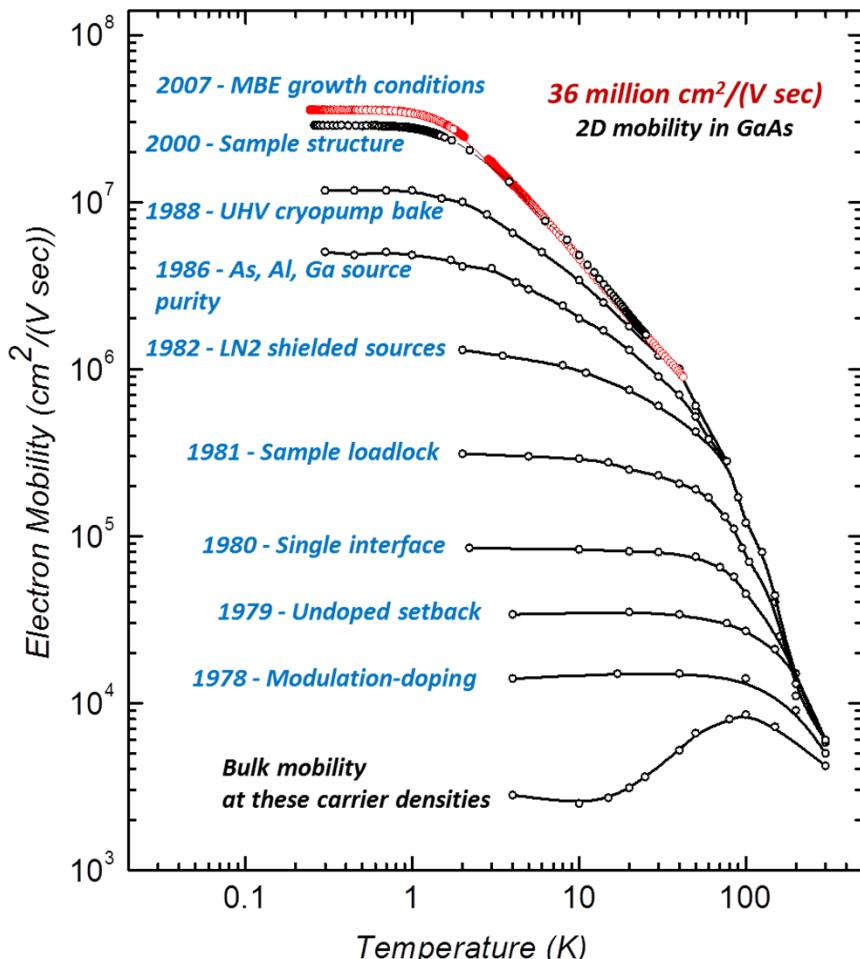


Courtesy of Phillip Smith  
(BAE Systems)



# Modulation-doped structures in physics

AlGaAs/GaAs heterostructure: perhaps *the most perfect crystalline interfacial system ever fabricated*



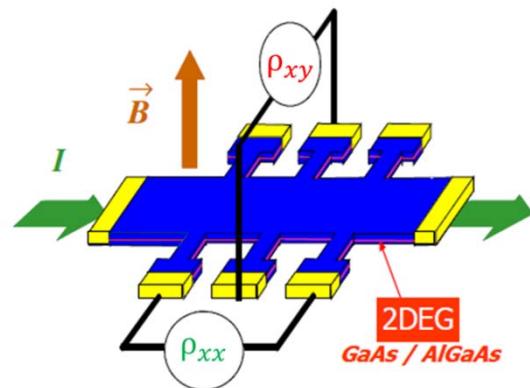
$$\mu_e = 3.6 \times 10^7 \text{ cm}^2/\text{V.s} \text{ at } 0.36 \text{ K}$$
$$(n_s = 3 \times 10^{11} \text{ cm}^{-2})$$

Umansky, JCG 2009

$\mu \uparrow$ : less disorder  
→ new physics!

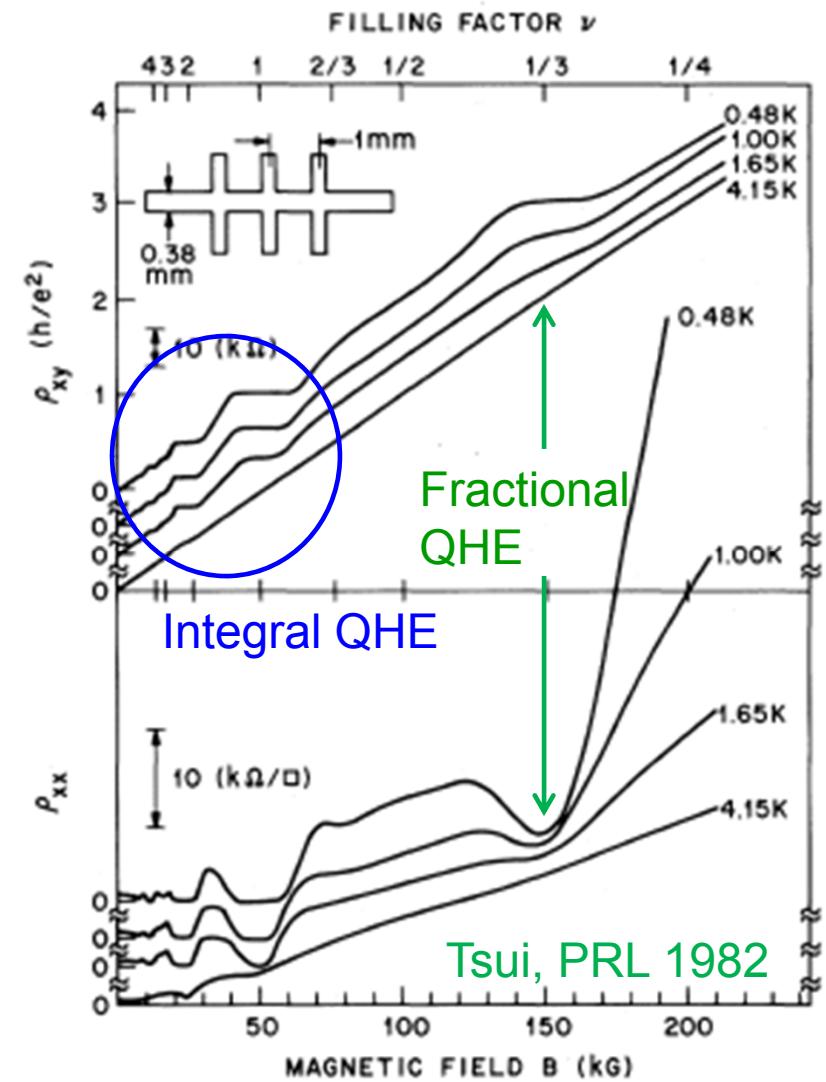
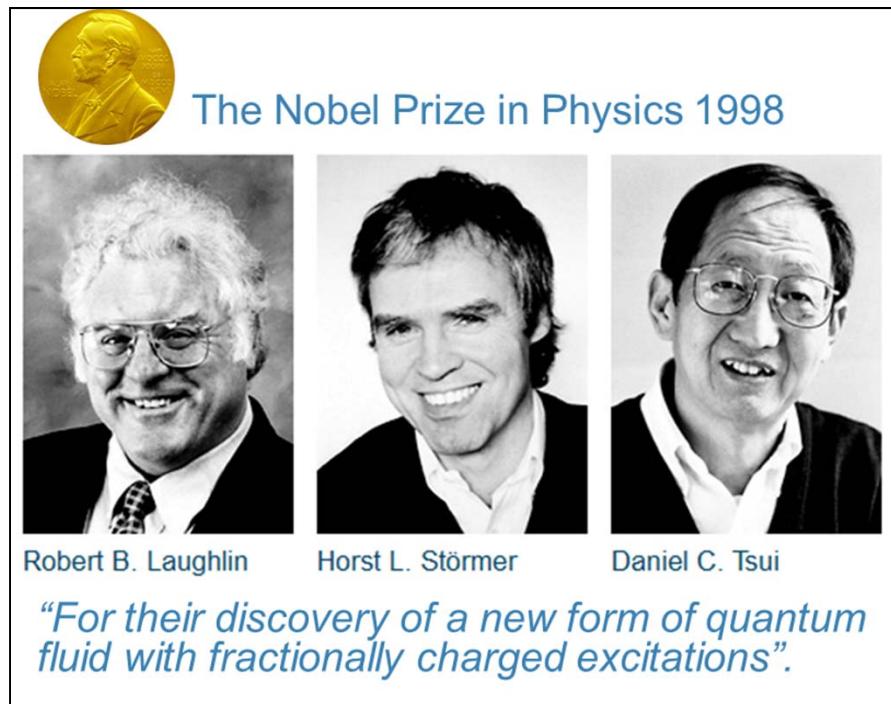
Courtesy of Loren Pfeiffer (Princeton)

# Fractional quantum-Hall effect



$$\rho_{xy} = \frac{h}{ie^2}$$

index



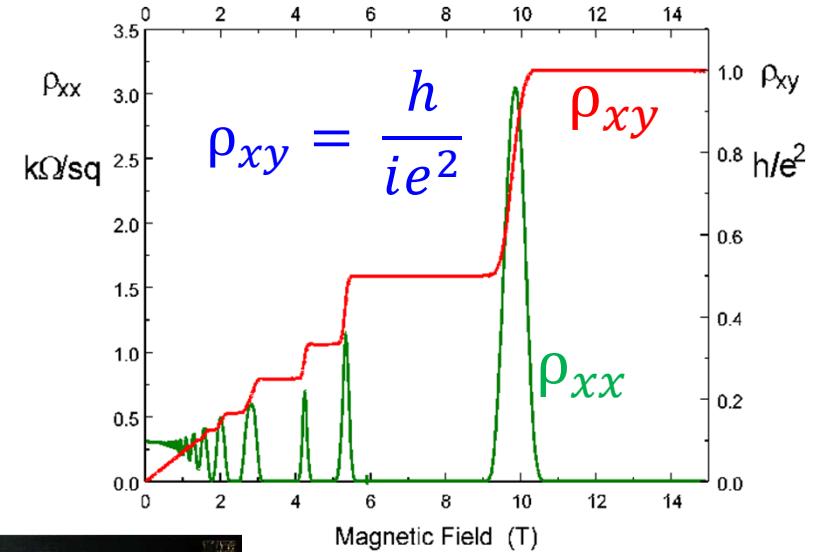
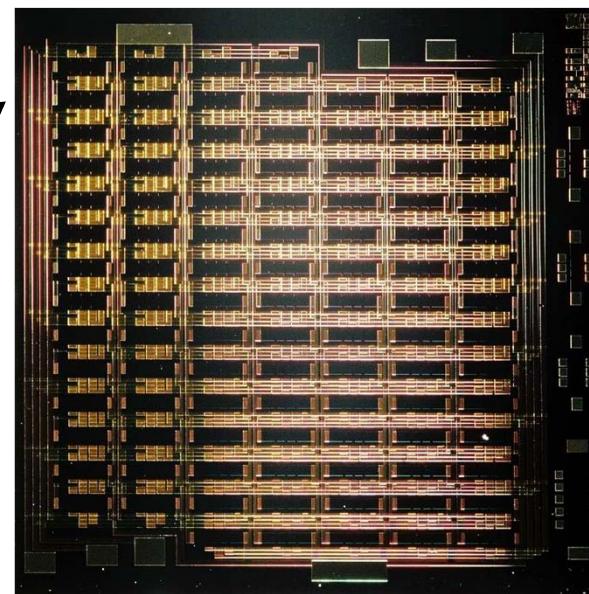
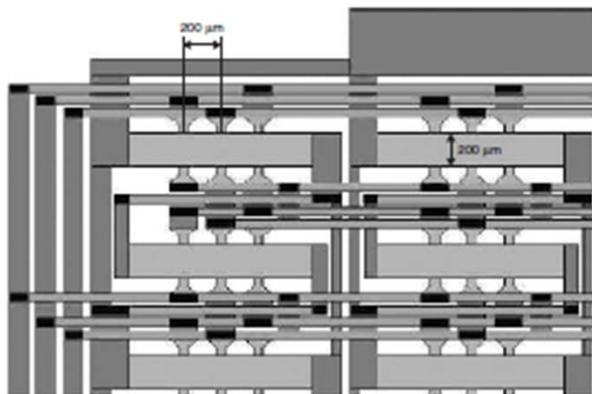
Discovered in sample with  $\mu_e = 9 \times 10^4$  cm<sup>2</sup>/V.s

# New international standard for Ohm: AlGaAs/GaAs quantum-Hall bar array

Hall plateaus in Integral QHE determined by fundamental constants  
→ use Hall resistance to define Ohm

## AlGaAs/GaAs quantum-Hall bar array:

- adopted in 1990 as standard for Ohm
- precision: few parts in  $10^9$ !
- 100 Hall bars
- $\mu_e \sim 6 \times 10^5 \text{ cm}^2/\text{V.s}$

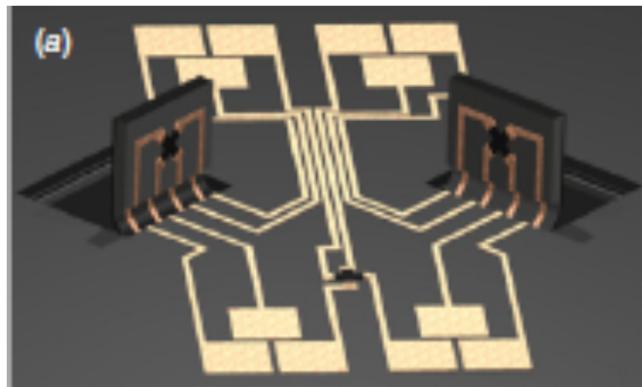


Previous Ohm standard (manganin wire):

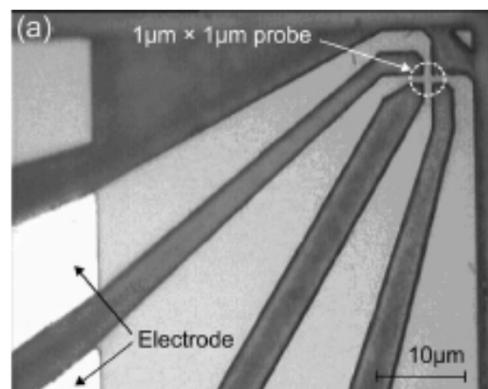


# **Future prospects**

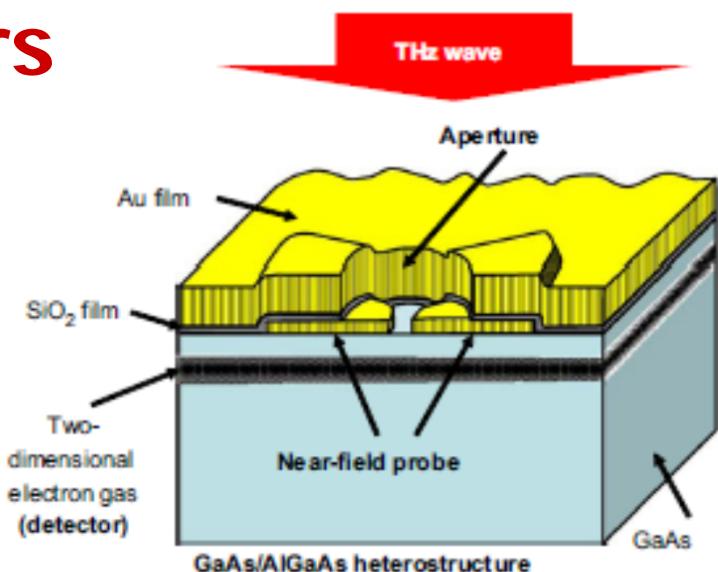
# New sensors



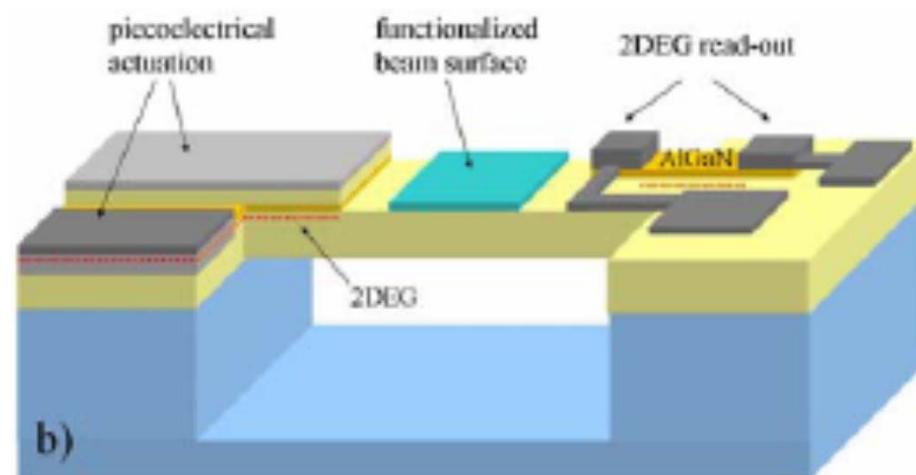
AlGaAs/GaAs 3-axis Hall  
sensors  
Todaro JMM 2010



InAlSb/InAsSb  
Micro-Hall sensors  
Bando, JAP 2009



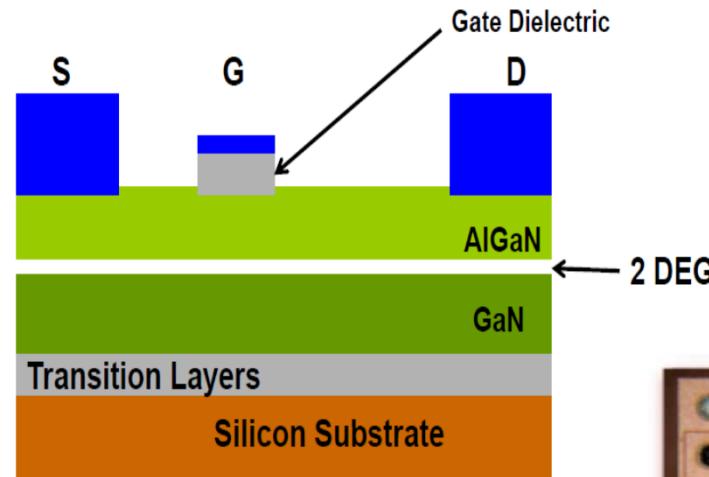
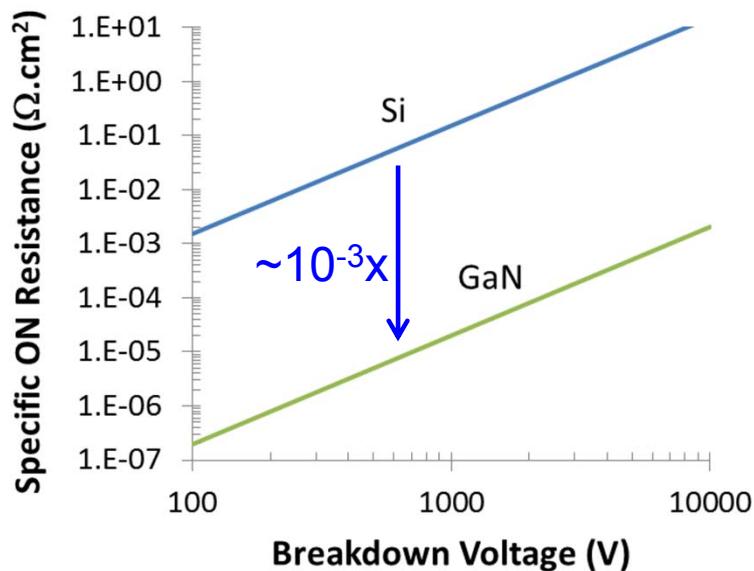
AlGaAs/GaAs THz devices  
Kawano, Phys E 2010



AlGaN/GaN Bio sensors  
Niebelshutz, PSSc 2008

# GaN power electronics

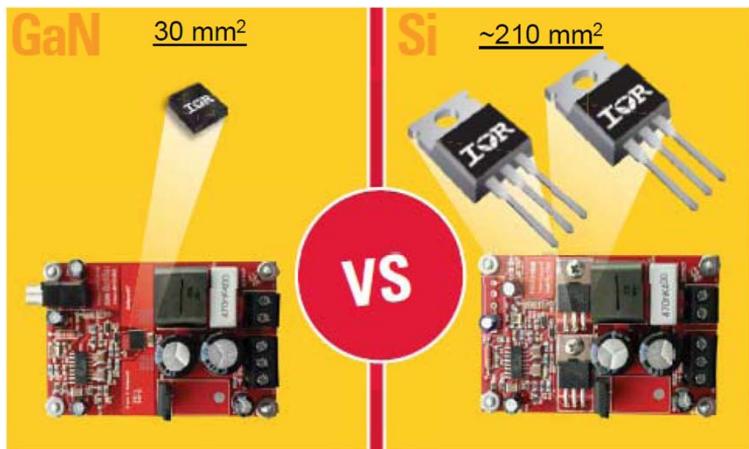
\$26B  
market in  
2008



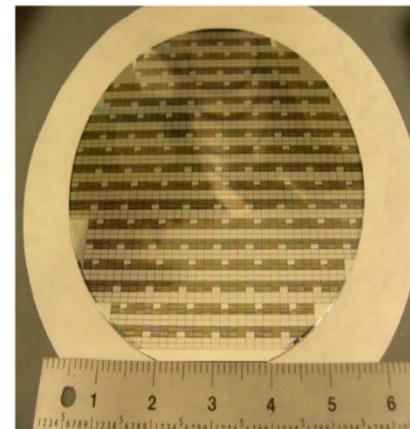
Briere, APEC 2011



GaN enables size shrink:



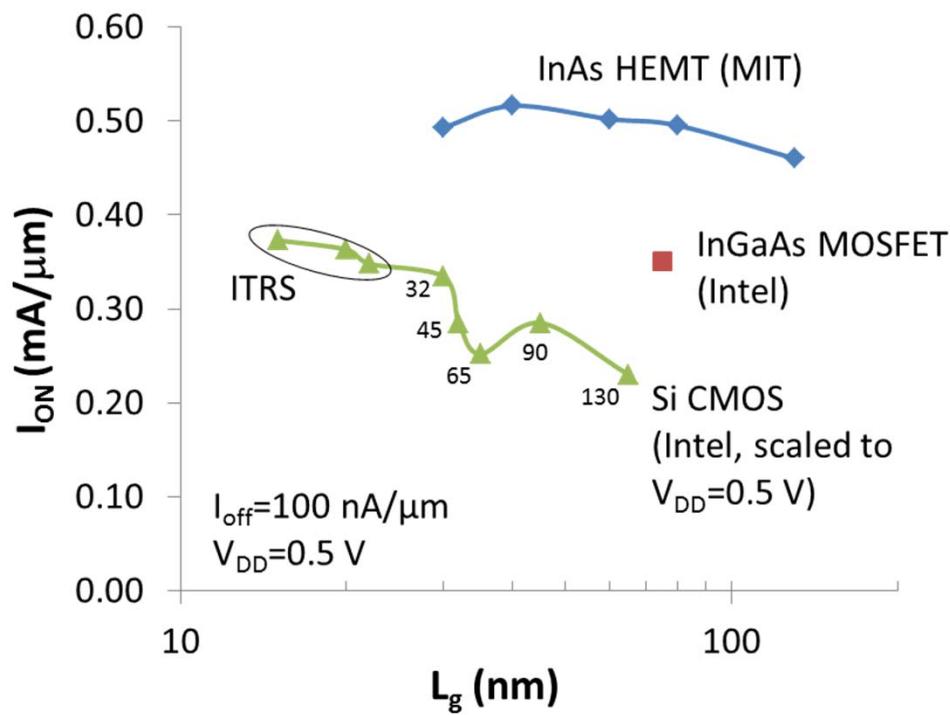
Si-like economics:



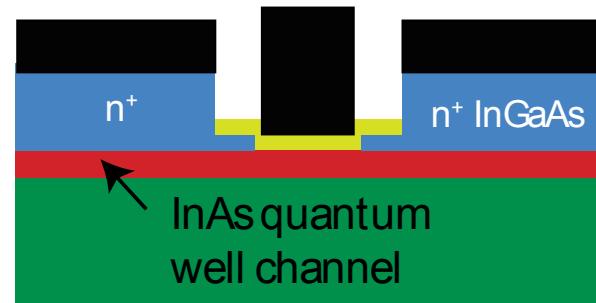
= 2-3x  
performance/cost  
advantage over Si

# III-V CMOS

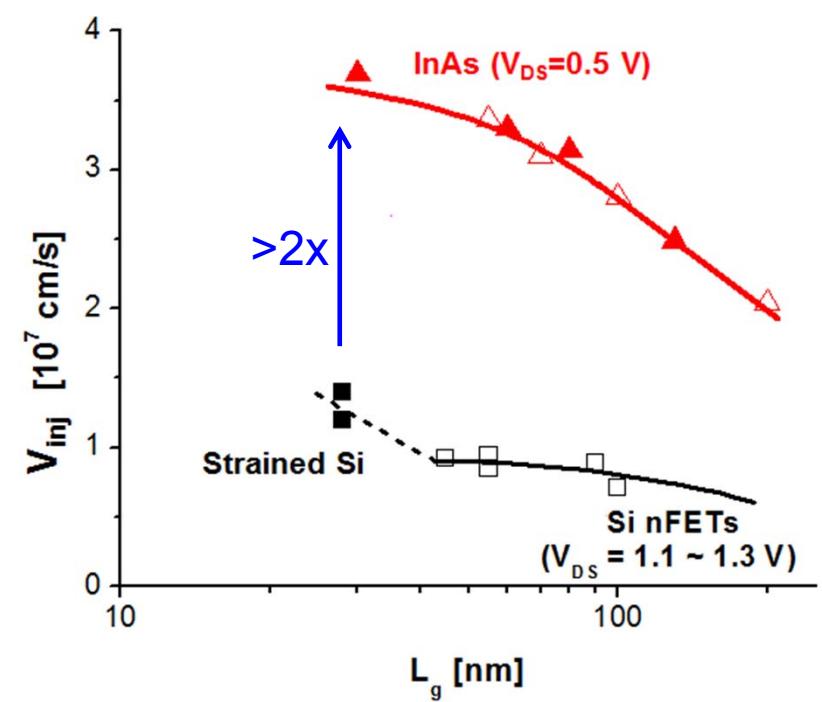
III-V FETs exceed logic performance of Si at 0.5 V



del Alamo, IPRM 2011



$v_{inj}$  in InGaAs >2x higher than Si at half the voltage



Kim, IEDM 2009

\$110B market  
in 2010!

## Epilogue:

### Kroemer's Lemma of New Technology

“The principal applications of any sufficiently new and innovative technology have always been – and will continue to be – applications *created by* that technology.”

Kroemer, Rev Mod Phys 2000

# Acknowledgements

- Ray Ashoori (MIT)
- Brian Bennett (NRL)
- Bobby Brar (Teledyne)
- P. C. Chao (BAE Systems)
- Takatomo Enoki (NTT)
- Augusto Gutierrez-Aitken (Northrop Grumman)
- Eric Higham (Strategy Analytics)
- Debdeep Jena (U. Notre Dame)
- Jose Jimenez (TriQuint Semiconductor)
- Marc Kastner (MIT)
- James Komiak (BAE Systems)
- Richard Lai (Northrop Grumman)
- Angie Locknar (MIT Libraries)
- Takashi Mimura (Fujitsu)
- Tomas Palacios (MIT)
- Loren Pfeiffer (Princeton)
- Philip Smith (BAE Systems)
- Tetsuya Suemitsu (Tohoku University)
- Ling Xia (MIT)